

6 Series MSO

Mixed Signal Oscilloscope Datasheet

*More speed. Lowest noise.
Exceptional measurement confidence.*



Confidence in numbers

Input channels

- 4 FlexChannel[®] inputs
- Each FlexChannel provides:
 - One analog signal that can be displayed as a waveform view, a spectral view, or both simultaneously
 - Eight digital logic inputs with TLP058 logic probe

Bandwidth (all analog channels)

- 1 GHz, 2.5 GHz, 4 GHz, 6 GHz, 8 GHz (upgradable)

Sample rate (all analog / digital channels)

- Real-time: 25 GS/s
- Interpolated: 2.5 TS/s

Record length (all analog / digital channels)

- 62.5 Mpoints standard
- 125 Mpoints and 250 Mpoints optional upgrades

Waveform capture rate

- >500,000 waveforms/s

Vertical resolution

- 12-bit ADC
- Up to 16-bits in High Res mode

Standard trigger types

- Edge, Pulse Width, Runt, Timeout, Window, Logic, Setup & Hold, Rise/Fall Time, Parallel Bus, Sequence, Visual Trigger, Video (optional)
- Auxiliary Trigger $\leq 5 V_{RMS}$, 50 Ω , 400 MHz (Edge Trigger only)

Standard analysis

- Cursors: Waveform, V Bars, H Bars, V&H Bars
- Measurements: 36
- Spectrum View: Frequency-domain analysis with independent controls for frequency and time domains. RF vs. time traces (magnitude, frequency, phase)
- FastFrame[™]: Segmented memory acquisition mode with maximum trigger rate >5,000,000 waveforms per second
- Plots: Time Trend, Histogram, Spectrum and Phase Noise
- Math: Basic waveform arithmetic, FFT, and advanced equation editor
- Search: Search on any trigger criteria
- Jitter: TIE and Phase Noise

Optional analysis

- Advanced Jitter and Eye Diagram Analysis
- Spectrum View
- Digital Power Management
- Mask/Limit Testing
- LVDS Debug and Analysis
- PAM3 Analysis
- Advanced Power Measurements and Analysis

Optional serial bus trigger, decode and analysis

- I²C, SPI, I3C, RS-232/422/485/UART, SPMI, CAN, CAN FD, LIN, FlexRay, SENT, PSI5, Automotive Ethernet, USB 2.0, Ethernet, Audio, MIL-STD-1553, ARINC 429, Spacewire, 8B/10B, NRZ

Optional serial compliance test

- Ethernet, USB 2.0, Automotive Ethernet, Industrial Ethernet, MIPI D-PHY 1.2

Optional memory analysis

- DDR3 debug, analysis, and compliance test

Arbitrary/Function Generator ¹

- 50 MHz waveform generation
- Waveform Types: Arbitrary, Sine, Square, Pulse, Ramp, Triangle, DC Level, Gaussian, Lorentz, Exponential Rise/Fall, Sin(x)/x, Random Noise, Haversine, Cardiac

Digital voltmeter ²

- 4-digit AC RMS, DC, and DC+AC RMS voltage measurements

Trigger frequency counter ²

- 8-digit

Display

- 15.6-inch (396 mm) TFT color
- High Definition (1,920 x 1,080) resolution
- Capacitive (multi-touch) touchscreen

Connectivity

- USB Host (7 ports), USB 3.0 Device (1 port), LAN (10/100/1000 Base-T Ethernet), Display Port, DVI-I, VGA

e*Scope[®]

- Remotely view and control the oscilloscope over a network connection through a standard web browser

¹ Optional and upgradable.

² Free with product registration.

Warranty

- 3 years standard

Dimensions

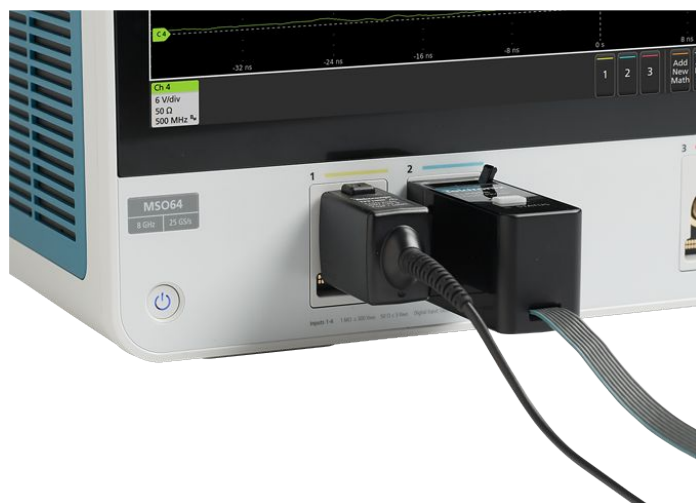
- 12.2 in (309 mm) H x 17.9 in (454 mm) W x 8.0 in (204 mm) D
- Weight: <28.4 lbs. (12.88 kg)

With the lowest input noise and up to 8 GHz analog bandwidth, the 6 Series MSO provides the best signal fidelity for analyzing and debugging today's embedded systems with GHz clock and bus speeds. The remarkably innovative pinch-swipe-zoom touchscreen user interface coupled with the industry's largest high definition display and 4 FlexChannel® inputs that let you measure one analog or eight digital signals per channel, the 6 Series MSO is ready for today's toughest challenges and tomorrow's too.

FlexChannel® technology enables maximum flexibility and broader system visibility

The 6 Series MSO redefines what a Mixed Signal Oscilloscope (MSO) should be. FlexChannel technology enables each channel input to be used as a single analog channel, eight digital logic inputs (with the TLP058 logic probe), or simultaneous analog and spectrum views with independent acquisition controls for each domain. Imagine the flexibility and configurability this provides.

You can change the configuration at any time by simply adding or removing TLP058 logic probes, so you always have the right number of digital channels.

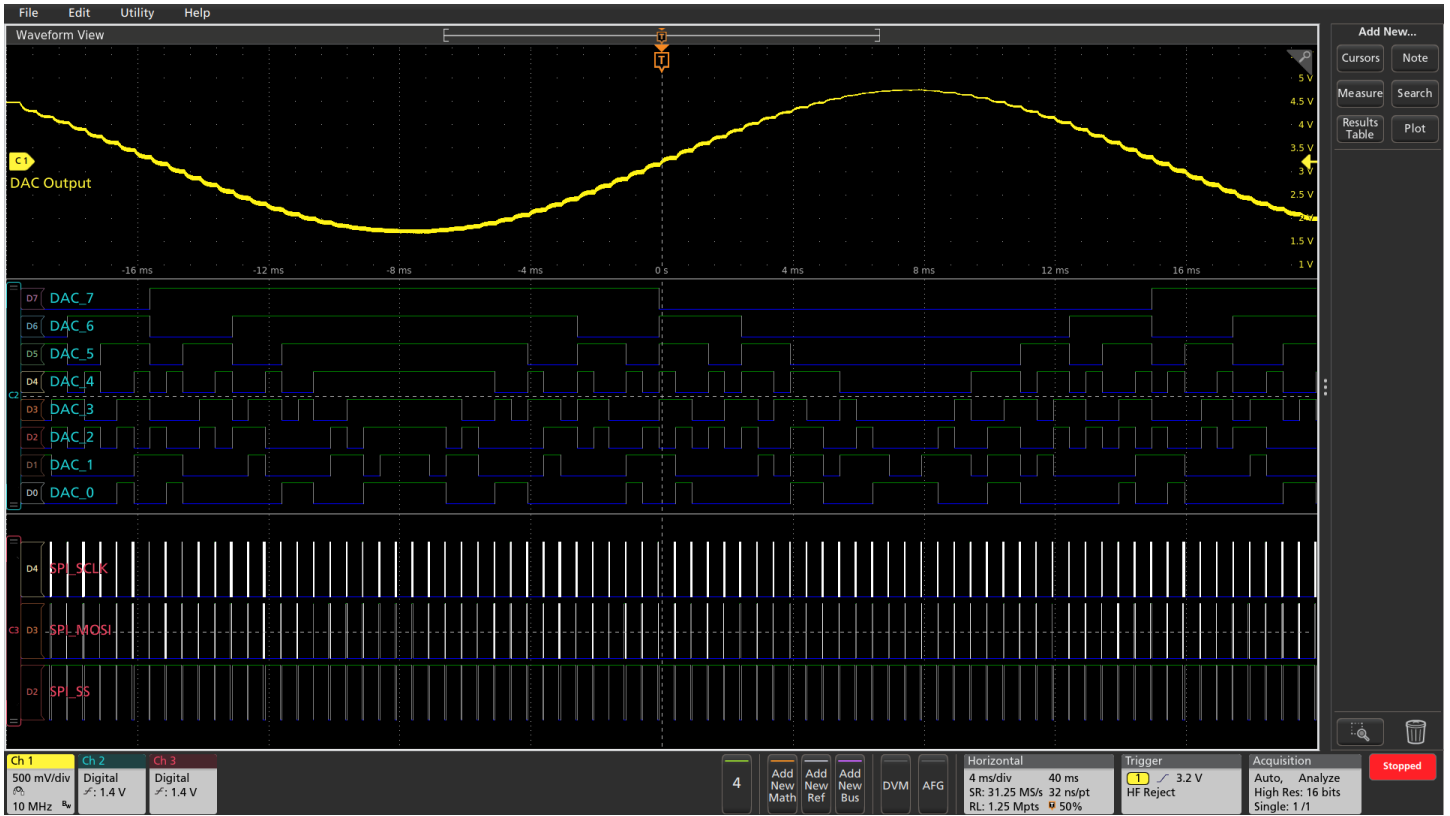


FlexChannel technology enables the ultimate in flexibility. Each input can be configured as a single analog or eight digital channels based on the type of probe you attach.

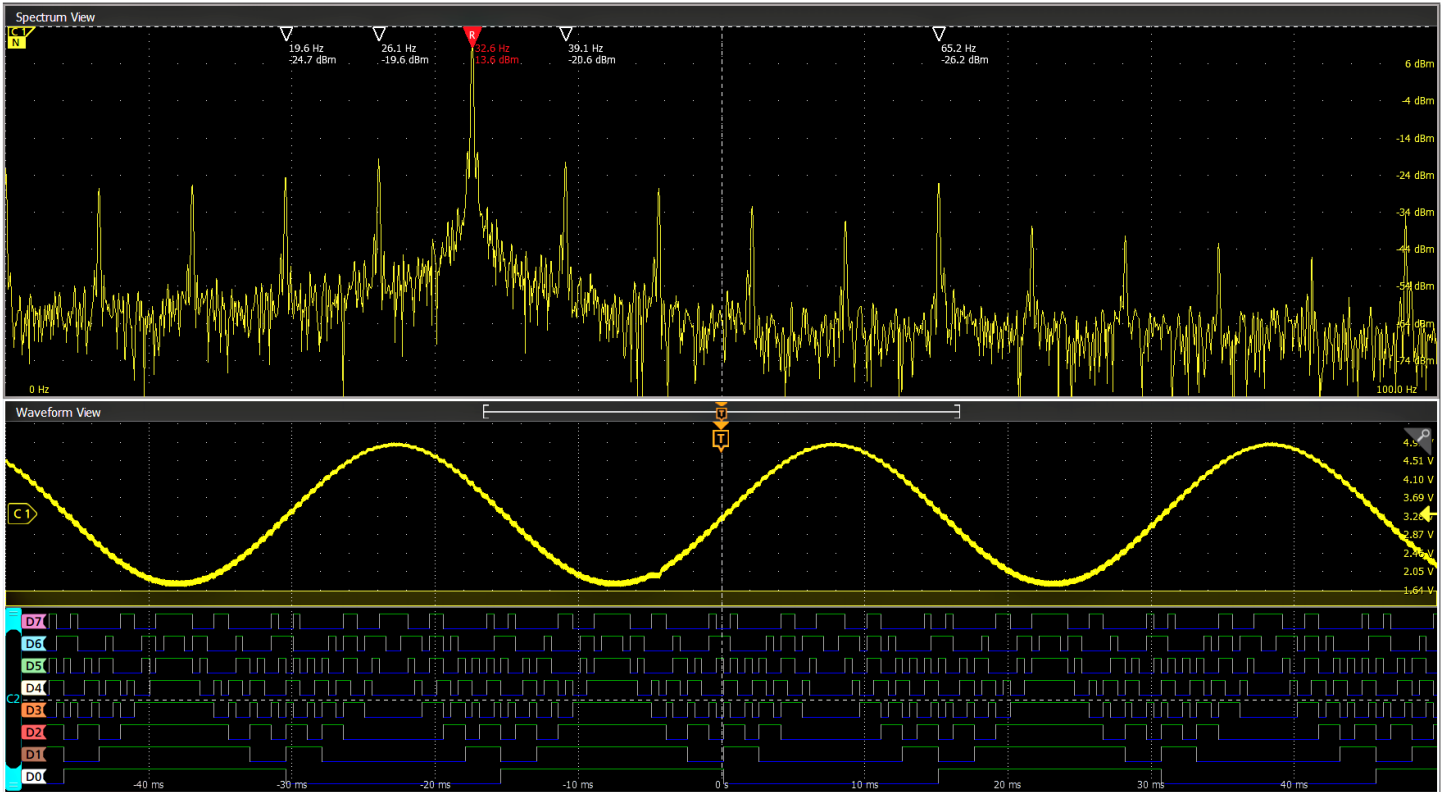
Previous-generation MSOs required tradeoffs, with digital channels having lower sample rates or shorter record lengths than analog channels. The 6 Series MSO offers a new level of integration of digital channels. Digital channels share the same high sample rate (up to 25 GS/s), and long record length (up to 250) Points for analog channels.



The TLP058 provides eight high performance digital inputs. Connect as many TLP058 probes as you like, enabling up to a maximum of 32 digital channels.



Channel 2 has a TLP058 Logic Probe connected to the eight inputs of a DAC. Notice the green and blue color coding, where ones are green and zeros are blue. Another TLP058 Logic Probe on Channel 3 is probing the SPI bus driving the DAC. The white edges indicate higher frequency information is available by either zooming in or moving to a faster sweep speed on the next acquisition.

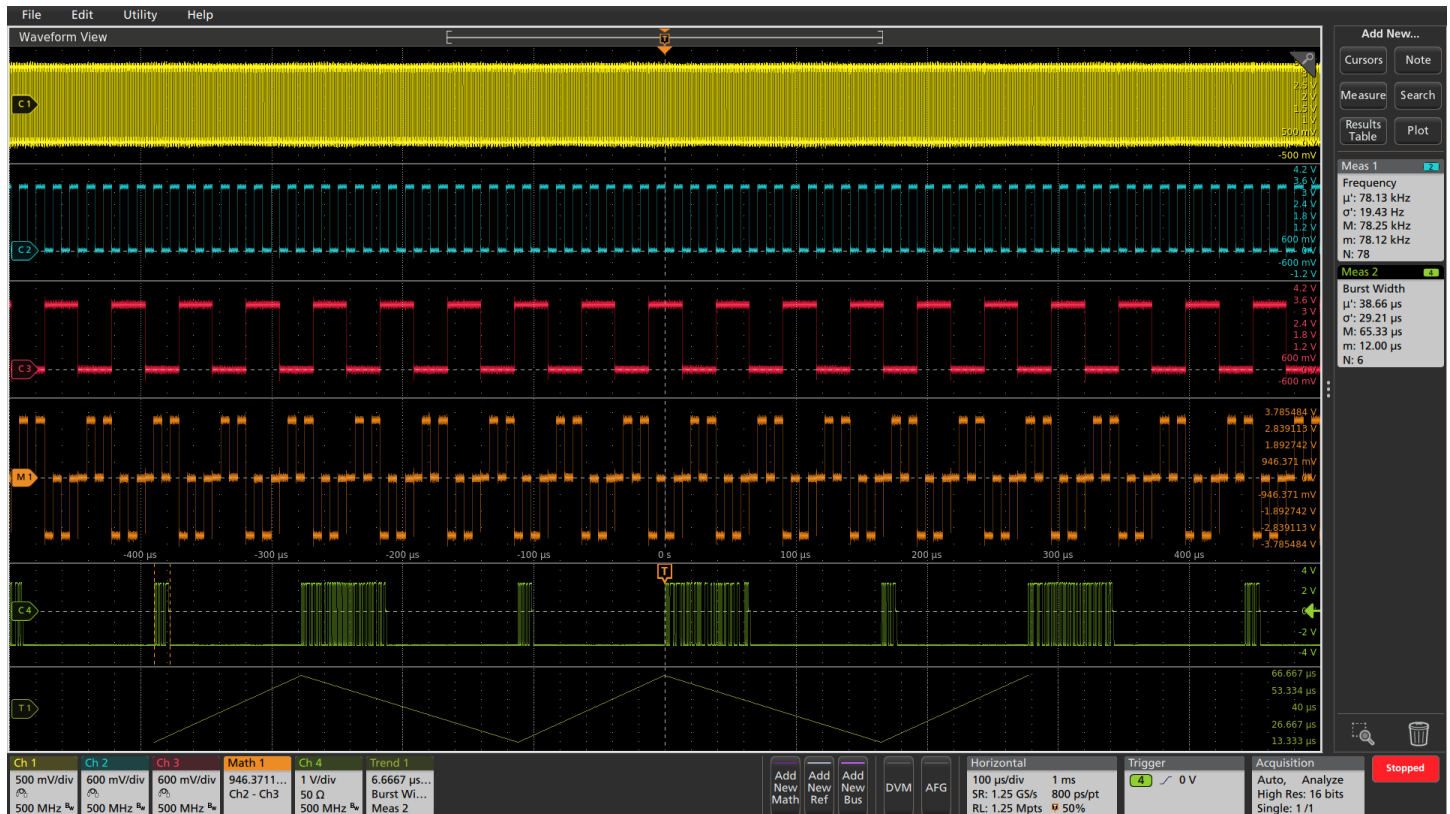


Beyond just analog and digital, FlexChannel inputs include Spectrum View. This Tektronix-patented technology enables you to simultaneously view both analog and spectral views of all your analog signals, with independent controls in each domain. For the first time ever, oscilloscope-based frequency-domain analysis is as easy as using a spectrum analyzer while retaining the ability to correlate frequency-domain activity with other time-domain phenomena.

Unprecedented signal viewing capability

The stunning 15.6" (396 mm) display in the 6 Series MSO is the largest display in the industry. It is also the highest resolution display, with full HD resolution (1,920 x 1,080), enabling you to see many signals at once with ample room for critical readouts and analysis.

The viewing area is optimized to ensure that the maximum vertical space is available for waveforms. The Results Bar on the right can be hidden, enabling the waveform view to use the full width of the display.



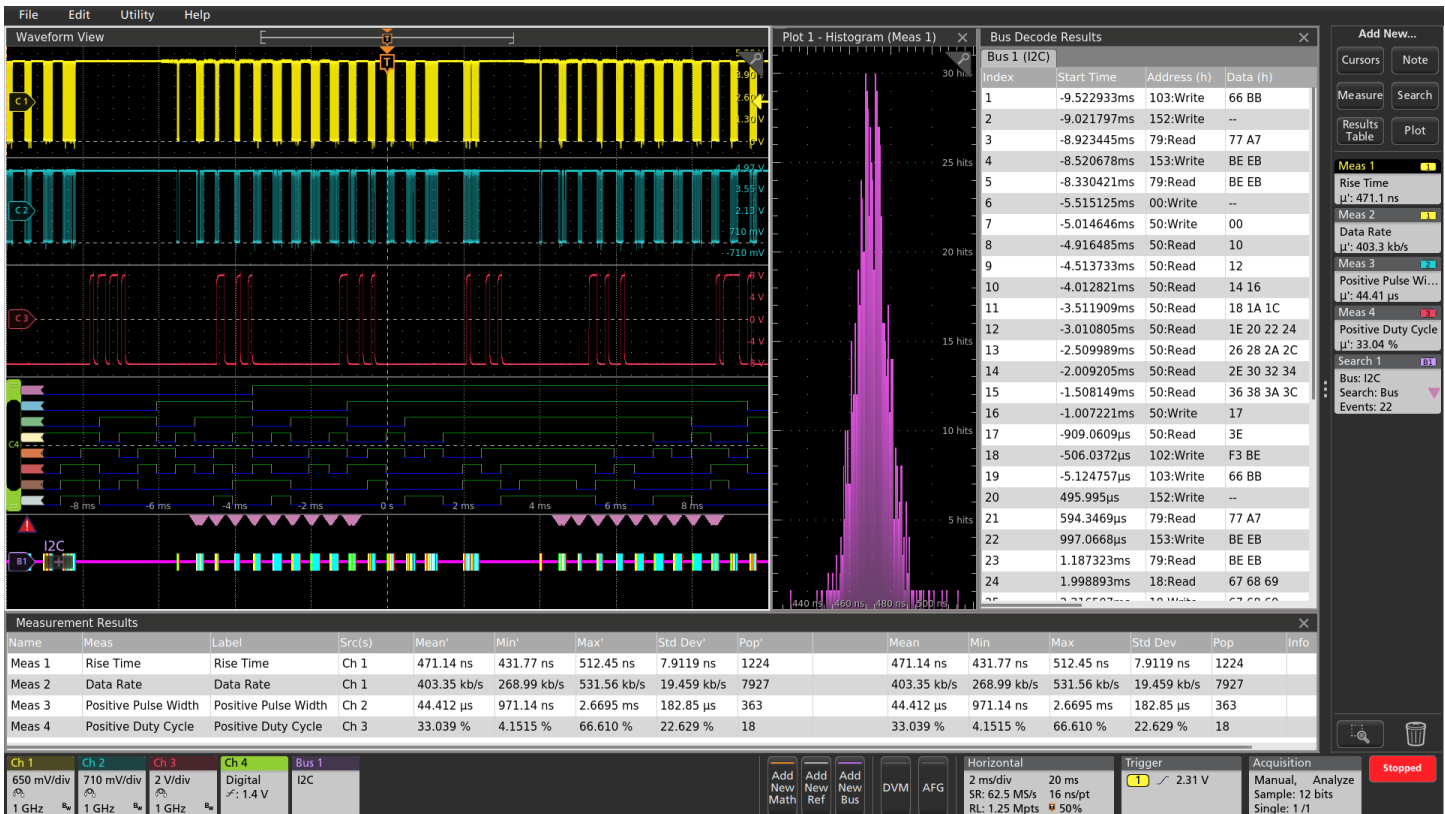
Stacked display mode enables easy visibility of all waveforms while maintaining maximum ADC resolution on each input for the most accurate measurements.

The 6 Series MSO offers a revolutionary new Stacked display mode. Historically, scopes have overlaid all waveforms in the same graticule, forcing difficult tradeoffs:

- To make each waveform visible, you vertically scale and position each waveform so that they don't overlap. Each waveform uses a small percentage of the available ADC range, leading to less accurate measurements.
- For measurement accuracy, you vertically scale and position each waveform to cover the entire display. The waveforms overlap each other, making it hard to distinguish signal details on individual waveforms

The new Stacked display eliminates this tradeoff. It automatically adds and removes additional horizontal waveform 'slices' (additional graticules) as waveforms are created and removed. Each slice represents the full ADC range for the waveform. All waveforms are visually separated from each other while still using the full ADC range, enabling maximum visibility and accuracy. And it's all done automatically as waveforms are added or removed! Channels can easily be reordered in stacked display mode by dragging and dropping the channel and waveform badges in the Settings bar at the bottom of the display. Groups of channels can also be overlaid within a slice to simplify visual comparison of signals.

The massive display in the 6 Series MSO also provides plenty of viewing area not only for signals, but also for plots, measurement results tables, bus decode tables and more. You can easily resize and relocate the various views to suit your application.



Viewing three analog channels, eight digital channels, a decoded serial bus waveform, decoded serial packet results table, four measurements, a measurement histogram, measurements results table with statistics and a search on serial bus events - simultaneously!

Exceptionally easy-to-use user interface lets you focus on the task at hand

The Settings Bar - key parameters and waveform management

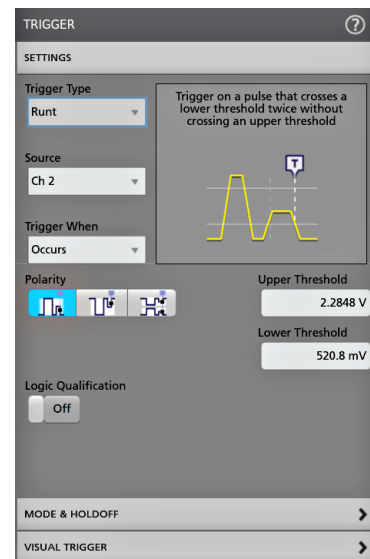
Waveform and scope operating parameters are displayed in a series of "badges" in the Settings Bar that runs along the bottom of the display. The Settings Bar provides immediate access for the most common waveform management tasks. With a single tap, you can:

- Turn on channels
- Add math waveforms
- Add reference waveforms
- Add bus waveforms
- Enable the optional integrated Arbitrary/Function generator (AFG)
- Enable the optional integrated digital voltmeter (DVM)

The Results Bar - analysis and measurements

The Results Bar on the right side of the display includes immediate, one-tap access to the most common analytical tools such as cursors, measurements, searches, measurement and bus decode results tables, plots, and notes.

DVM, measurement and search results badges are displayed in the Results Bar without sacrificing any waveform viewing area. For additional waveform viewing area, the Results Bar can be dismissed and brought back at any time.



Configuration menus are accessed by simply double-tapping on the item of interest on the display. In this case, the Trigger badge was double-tapped to open the Trigger configuration menu.

Touch interaction finally done right

Scopes have included touch screens for years, but the touch interface has been an afterthought. The 6 Series MSO's 15.6" display includes a capacitive touchscreen and provides the industry's first oscilloscope user interface truly designed for touch.

The touch interactions that you use with phones and tablets, and expect in a touch enabled device, are supported in the 6 Series MSO.

- Drag waveforms left/right or up/down to adjust horizontal and vertical position or to pan a zoomed view
- Pinch and expand to change scale or zoom in/out in either horizontal or vertical directions
- Drag items to the trash can or drag them off the edge of the screen to delete them
- Swipe in from the right to reveal the Results Bar or down from the top to access the menus in the upper left corner of the display

Smooth, responsive front panel controls allow you to make adjustments with familiar knobs and buttons, and you can add a mouse or keyboard as a third interaction method.



Interact with the capacitive touch display in the same way you do on your phones and tablets.

Variable font size

Historically, oscilloscope user interfaces have been designed with fixed font sizes to optimize viewing of waveforms and readouts. This implementation is fine if all users have the same viewing preferences, but they don't. Users spend a significant amount of time staring at screens, and Tektronix recognizes this. The 6 Series MSO offers a user preference for variable font sizes; scaling down to 12 points or up to 20 points. As you adjust the font size, the user interface dynamically scales so you can easily choose the best size for your application.



Comparison showing how the user interface scales as font size changes.



Efficient and intuitive front panel provides critical controls while still leaving room for the massive 15.6" high definition display.

Attention to detail in the front-panel controls

Traditionally, the front face of a scope has been roughly 50% display and 50% controls. The 6 Series MSO display fills about 85% of the face of the instrument. To achieve this, it has a streamlined front panel that retains critical controls for simple intuitive operation, but with a reduced number of menu buttons for functions directly accessed via objects on the display.

Color-coded LED light rings indicate trigger source and vertical scale/ position knob assignments. Large, dedicated Run/ Stop and Single Sequence buttons are placed prominently in the upper right, and other functions like Force Trigger, Trigger Slope, Trigger Mode, Default Setup, Autoset and Quick-save functions are all available using dedicated front panel buttons.

Windows or not - you choose

The 6 Series MSO offers you the choice of whether to include a Microsoft Windows™ operating system. Opening an access panel on the bottom of the instrument reveals a connection for a solid state drive (SSD). When the SSD is not present, the instrument boots as a dedicated scope with no ability to run or install other programs.



When the SSD is present, the instrument boots in an open Windows 10 configuration, so you can minimize the oscilloscope application and access a Windows desktop where you can install and run additional applications on the oscilloscope. Or you can connect additional monitors and extend your desktop.

Whether you run Windows or not, the oscilloscope operates in exactly the same way with the same look and feel and UI interaction.

Need higher channel density?

The 6 Series is also available as a low-profile digitizer - the LPD64. With four SMA input channels plus an auxiliary trigger input, in a 2U high package and 12-bit ADC's, the 6 Series Low Profile Digitizer sets a new standard for performance in applications where extreme channel density is required.

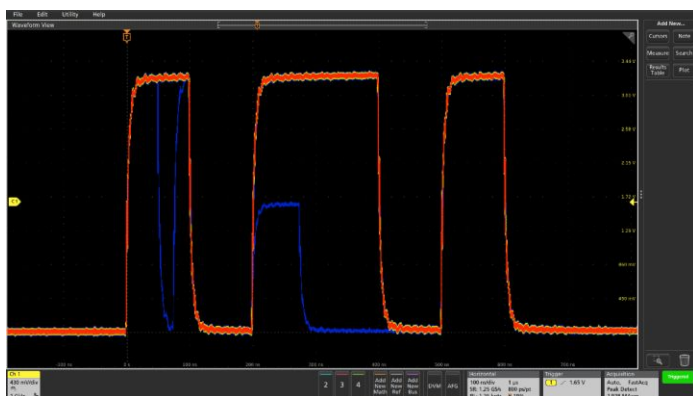


Experience the performance difference

With up to 8 GHz analog bandwidth, 25 GS/s sample rates, standard 62.5 Mpts record length and a 12-bit analog to digital converter (ADC), the 6 Series MSO has the performance you need to capture waveforms with the best possible signal fidelity and resolution for seeing small waveform details.

Digital Phosphor technology with FastAcq™ high-speed waveform capture

To debug a design problem, first you must know it exists. Digital phosphor technology with FastAcq provides you with fast insight into the real operation of your device. Its fast waveform capture rate - greater than 500,000 waveforms per second - gives you a high probability of seeing the infrequent problems common in digital systems: runt pulses, glitches, timing issues, and more. To further enhance the visibility of rarely occurring events, intensity grading indicates how often rare transients are occurring relative to normal signal characteristics.



FastAcq's high waveform capture rate enables you to discover infrequent problems common in digital design.

Industry leading vertical resolution and low noise

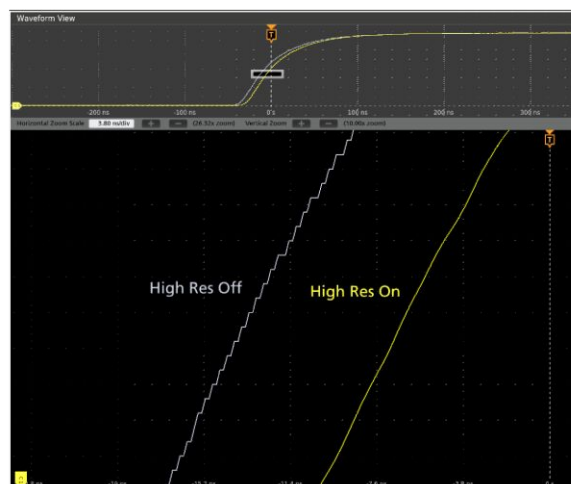
The 6 Series MSO provides the performance to capture the signals of interest while minimizing the effects of unwanted noise when you need to capture high-amplitude signals while seeing smaller signal details. At the heart of the 6 Series MSO are 12-bit analog-to-digital converters (ADCs) that provide 16 times the vertical resolution of traditional 8-bit ADCs.

A new High Res mode applies a hardware-based unique Finite Impulse Response (FIR) filter based on the selected sample rate. The FIR filter maintains the maximum bandwidth possible for that sample rate while preventing aliasing and removing noise from the oscilloscope amplifiers and ADC above the usable bandwidth for the selected sample rate.

High Res mode always provides at least 12 bits of vertical resolution and extends all the way to 16 bits of vertical resolution at ≤ 625 MS/s sample rates and 200 MHz of bandwidth. The following table shows the number of bits of vertical resolution for each sample rate setting when in High Res.

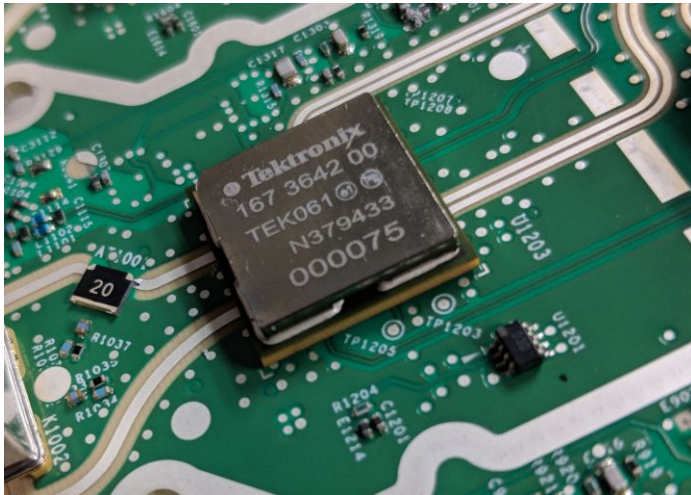
| Sample rate | Number of bits of vertical resolution |
|-----------------|---------------------------------------|
| 25 GS/s | 8 |
| 12.5 GS/s | 12 |
| 6.25 GS/s | 13 |
| 3.125 GS/s | 14 |
| 1.25 GS/s | 15 |
| ≤ 625 MS/s | 16 |

New lower-noise front end amplifiers further improve the 6 Series MSO's ability to resolve fine signal detail.



The 6 Series MSO's 12-bit ADC, along with the new High Res mode, enable industry leading vertical resolution.

A new TEK061 front end amplifier sets a new standard for low-noise acquisition providing the best signal fidelity to capture small signals with high resolution.



A key attribute to being able to view fine signal details on small, high-speed signals is noise. The higher a measurement systems' intrinsic noise, the less true signal detail will be visible. This becomes more critical on an oscilloscope when the vertical settings are set to high sensitivity (like $\leq 10\text{mV/div}$) in order to view small signals that are prevalent in high-speed bus topologies. The 6 Series MSO has a new front-end ASIC, the TEK061, that enables breakthrough noise performance at the highest sensitivity settings. The table below shows a comparison of typical noise performance of the 6 Series MSO and prior generations of Tektronix oscilloscopes in this bandwidth range.

50 Ω , RMS voltage, typical

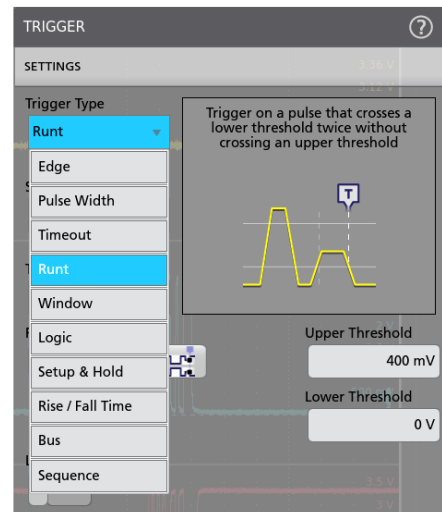
| Bandwidth | V/Div | 6 Series MSO | DPO7000C | MSO/ DPO70000C |
|-----------|--------|--------------------|-------------------------------|-------------------|
| 1 GHz | 1 mV | 54.8 μV | 90 μV ³ | N/A |
| | 10 mV | 90.9 μV | 279 μV | N/A |
| | 100 mV | 941 μV | 2.7 mV | N/A |
| 4 GHz | 1 mV | 97.4 μV | N/A | N/A |
| | 10 mV | 192 μV | N/A | 500 μV |
| | 100 mV | 1.92 mV | N/A | 4.3 mV |
| 8 GHz | 1 mV | 158 μV | N/A | N/A |
| | 10 mV | 342 μV | N/A | 580 μV |
| | 100 mV | 3.46 mV | N/A | 4.5 mV |

Triggering

Discovering a device fault is only the first step. Next, you must capture the event of interest to identify root cause. The 6 Series MSO provides a complete set of advanced triggers, including:

- Runt
- Logic
- Pulse width
- Window
- Timeout
- Rise/Fall time
- Setup and Hold violation
- Serial packet
- Parallel data
- Sequence
- Video
- Visual Trigger

With up to a 250 Mpoint record length, you can capture many events of interest, even thousands of serial packets in a single acquisition, providing high-resolution to zoom in on fine signal details and record reliable measurements.



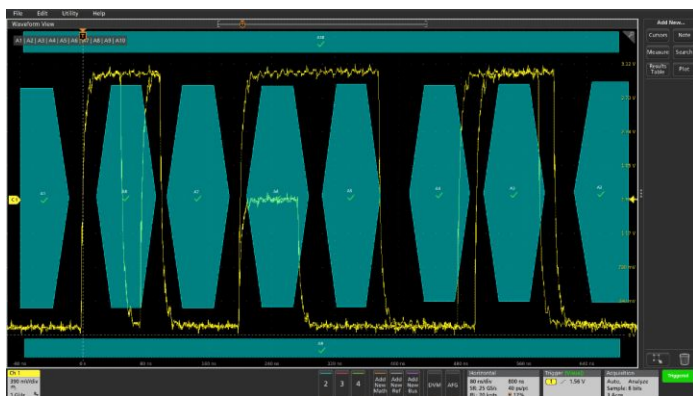
The wide variety of trigger types and context-sensitive help in the trigger menu make it easier than ever to isolate the event of interest.

³ Bandwidth limited to 200 MHz.

Visual trigger - Finding the signal of interest quickly

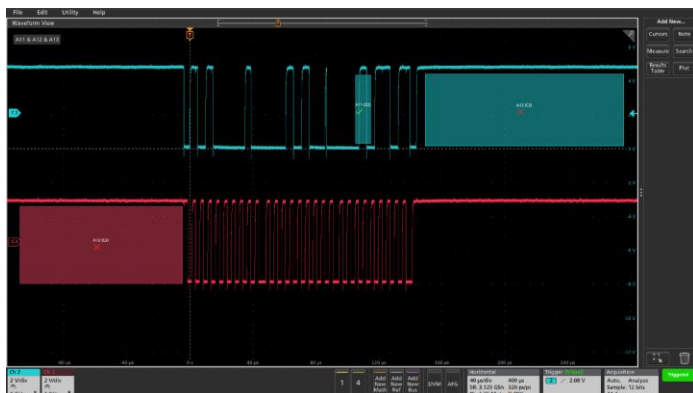
Finding the right cycle of a complex bus can require hours of collecting and sorting through thousands of acquisitions for an event of interest. Defining a trigger that isolates the desired event speeds up debug and analysis efforts.

Visual Trigger extends the 6 Series MSO's triggering capabilities by scanning through all waveform acquisitions and comparing them to on-screen areas (geometric shapes). An unlimited number of areas can be created using a mouse or touchscreen, and a variety of shapes (triangles, rectangles, hexagons, or trapezoids) can be used to specify the desired trigger behavior. Once shapes are created, they can be edited interactively to create custom shapes and ideal trigger conditions.



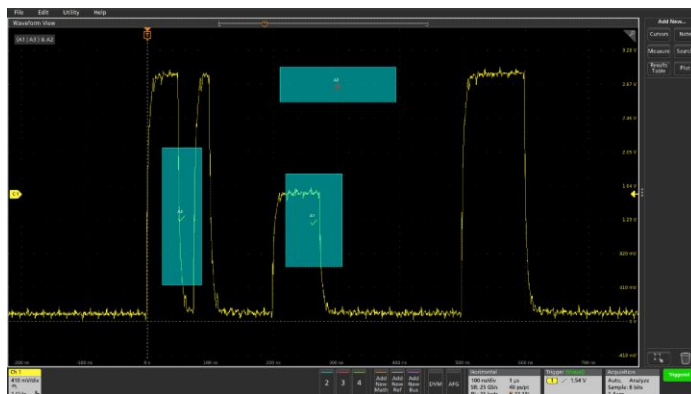
Visual Trigger areas isolate an event of interest, saving time by only capturing the events you want to see.

By triggering only on the most important signal events, Visual Trigger can save hours of capturing and manually searching through acquisitions. In seconds or minutes, you can find the critical events and complete your debug and analysis efforts. Visual Trigger even works across multiple channels, extending its usefulness to complex system troubleshooting and debug tasks.



Multiple channel triggering. Visual Trigger areas can be associated with events spanning multiple channels such as packets transmitted on two bus signals simultaneously.

Once multiple areas are defined, a Boolean logic equation can be used to set complex trigger conditions using on-screen editing features.



Boolean logic trigger qualification. Boolean logic using logical OR allows triggering on a specific anomaly in the signal.

TekVPI Probe Interface

The TekVPI[®] probe interface sets the standard for ease of use in probing. In addition to the secure, reliable connection that the interface provides, many TekVPI probes feature status indicators and controls, as well as a probe menu button right on the comp box itself. This button brings up a probe menu on the oscilloscope display with all relevant settings and controls for the probe. The TekVPI interface enables direct attachment of current probes without requiring a separate power supply. TekVPI probes can be controlled remotely through USB or LAN, enabling more versatile solutions in ATE environments. The 6 Series MSO provides up to 40 W of power to the front panel connectors, sufficient to power all connected TekVPI probes without the need for an additional probe power supply.

Convenient high speed passive voltage probing

The TPP Series passive voltage probes included with every 6 Series MSO offer all the benefits of general-purpose probes -- high dynamic range, flexible connection options, and robust mechanical design -- while providing the performance of active probes. Up to 1 GHz analog bandwidth enables you to see high frequency components in your signals, and extremely low 3.9 pF capacitive loading minimizes adverse effects on your circuits and is more forgiving of longer ground leads.

An optional, low-attenuation (2X) version of the TPP probe is available for measuring low voltages. Unlike other low-attenuation passive probes, the TPP0502 has high bandwidth (500 MHz) as well as low capacitive loading (12.7 pF).



6 Series MSOs come standard with one TPP1000 (1 GHz, 2.5 GHz models) probe per channel.

TDP7700 Series TriMode Probes

The TDP7700 Series TriMode probes provide the highest probe fidelity available for real-time oscilloscopes. The TDP7700 is designed for use with the 6 Series MSO, with full AC calibration of the probe and tip's signal path based on unique S-parameter models. The probe communicates the S-parameters to the scope via the TekVPI probe interface and the 6 Series MSO includes them to achieve the very best signal fidelity possible from probe tip to acquisition memory. Connectivity innovations such as solder-down tips with the probe's input buffer mounted only a few millimeters from the end of the tip, the TDP7700 Series probes provide unmatched usability for connecting to today's most challenging electronic designs.



TDP7700 Series probe with a selection of available tips

With TriMode probing one probe setup makes differential, single ended, and common mode measurements accurately. This unique capability allows you to work more effectively and efficiently, switching between differential, single ended and common mode measurements without moving the probe's connection point.

IsoVu™ Isolated Measurement System

Whether designing an inverter, optimizing a power supply, testing communication links, measuring across a current shunt resistor, debugging EMI or ESD issues, or trying to eliminate ground loops in your test setup, common mode interference has caused engineers to design, debug, evaluate, and optimize "blind" until now.

Tektronix' revolutionary IsoVu technology uses optical communications and power-over-fiber for complete galvanic isolation. When combined with the 6 Series MSO equipped with the TekVPI interface, it is the first, and only, measurement system capable of accurately resolving high bandwidth, differential signals, in the presence of large common mode voltage with:

- Complete galvanic isolation
- Up to 1 GHz bandwidth
- 1 Million to 1 (120 dB) common mode rejection at 100 MHz
- 10,000 to 1 (80 dB) of common mode rejection at full bandwidth
- Up to 2,500 V differential dynamic range
- 60 kV common mode voltage range



The Tektronix TIVM Series IsoVu™ Measurement System offers a galvanically isolated measurement solution to accurately resolve high bandwidth, differential signals up to 2,500 Vpk in the presence of large common mode voltages, with the best in class common mode rejection performance across its bandwidth.

Comprehensive analysis for fast insight

Basic waveform analysis

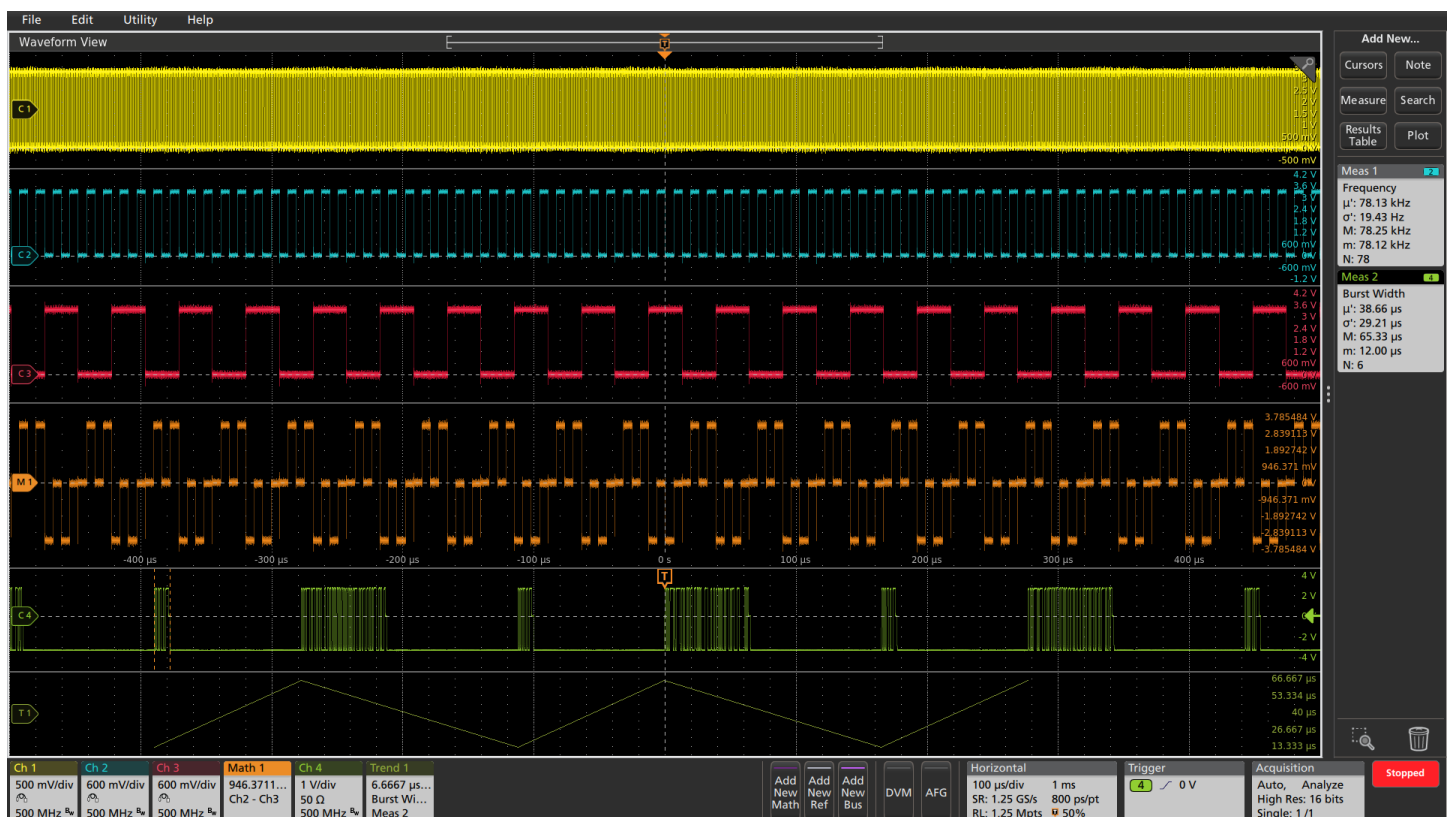
Verifying that your prototype's performance matches simulations and meets the project's design goals requires careful analysis, ranging from simple checks of rise times and pulse widths to sophisticated power loss analysis, characterization of system clocks, and investigation of noise sources.

The 6 Series MSO offers a comprehensive set of standard analysis tools including:

- Waveform- and screen-based cursors
- 36 automated measurements. Measurement results include all instances in the record, the ability to navigate from one occurrence to the next, and immediate viewing of the minimum or maximum result found in the record

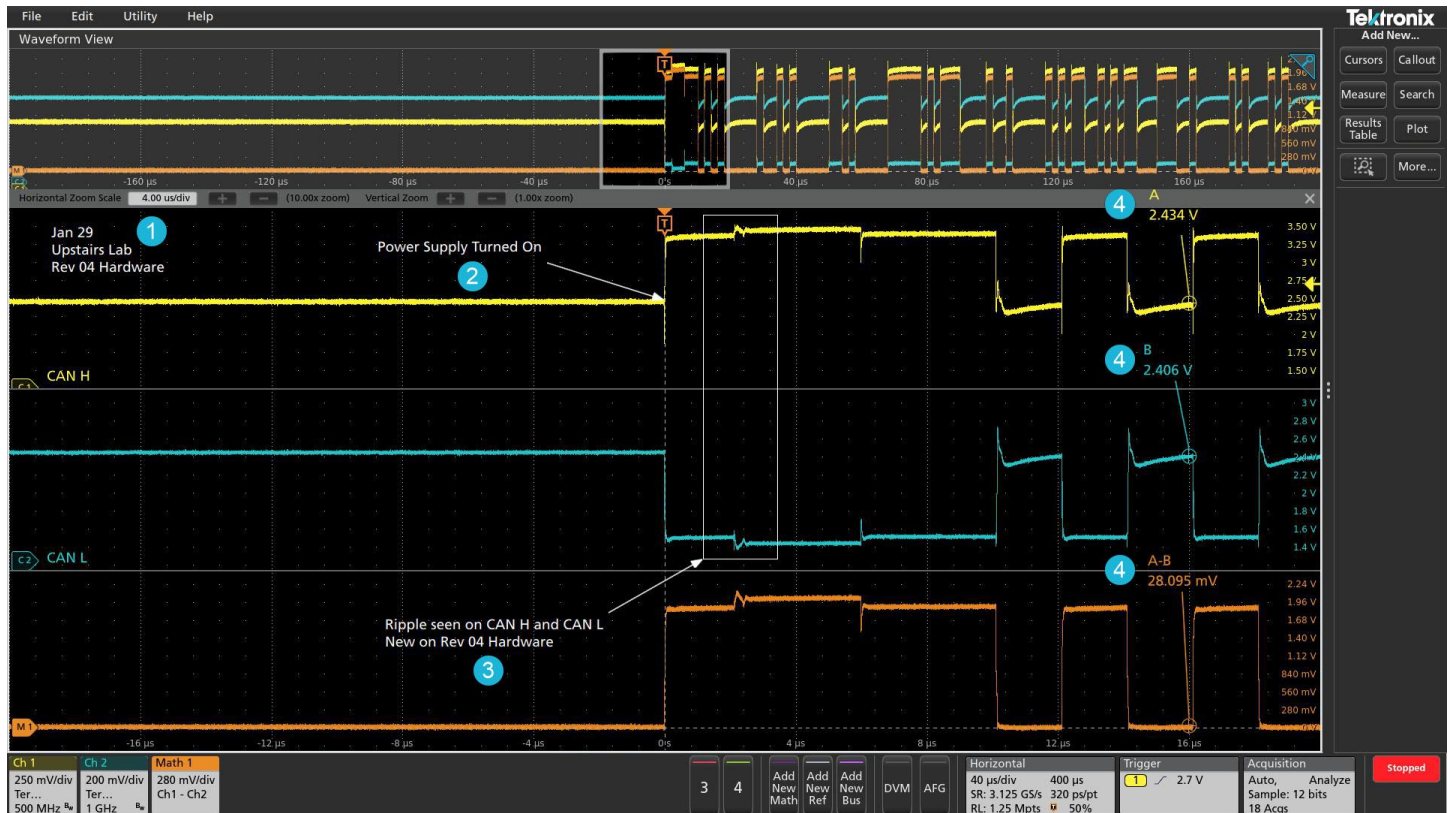
- Basic waveform math
- Basic FFT analysis
- Advanced waveform math including arbitrary equation editing with filters and variables
- FastFrame™ Segmented Memory enables you to make efficient use of the oscilloscope's acquisition memory by capturing many trigger events in a single record while eliminating the large time gaps between events of interest. View and measure the segments individually or as an overlay.

Measurement results tables provide comprehensive statistical views of measurement results with statistics across both the current acquisition and all acquisitions.



Using measurements to characterize burst width and Frequency.

Callouts



Easy to use callouts (Note, Arrow, Rectangle, Bookmark) that are detailing the specifics of this test setup and corresponding results.

- 1 **Note** Write and position a text box on the screen.
- 2 **Arrow** Write and position a text box, then add an arrow to a specific location on the screen.
- 3 **Rectangle** Write text and outline a specific region on the screen indicated by a resizable box.
- 4 **Bookmark** Create a dynamic readout at a specified time relative to a trigger point. This readout includes text, magnitude of the signal, signal units, as well as a line and target indicating the bookmark reference point.

Documenting test results and methods is critical when sharing data across a team, recreating a measurement at a later date, or delivering a customer report. With a few taps on the screen, you can create as many custom callouts as needed; enabling you to document the specific details of your test results. With each callout, you can customize the text, location, color, font size, and font.

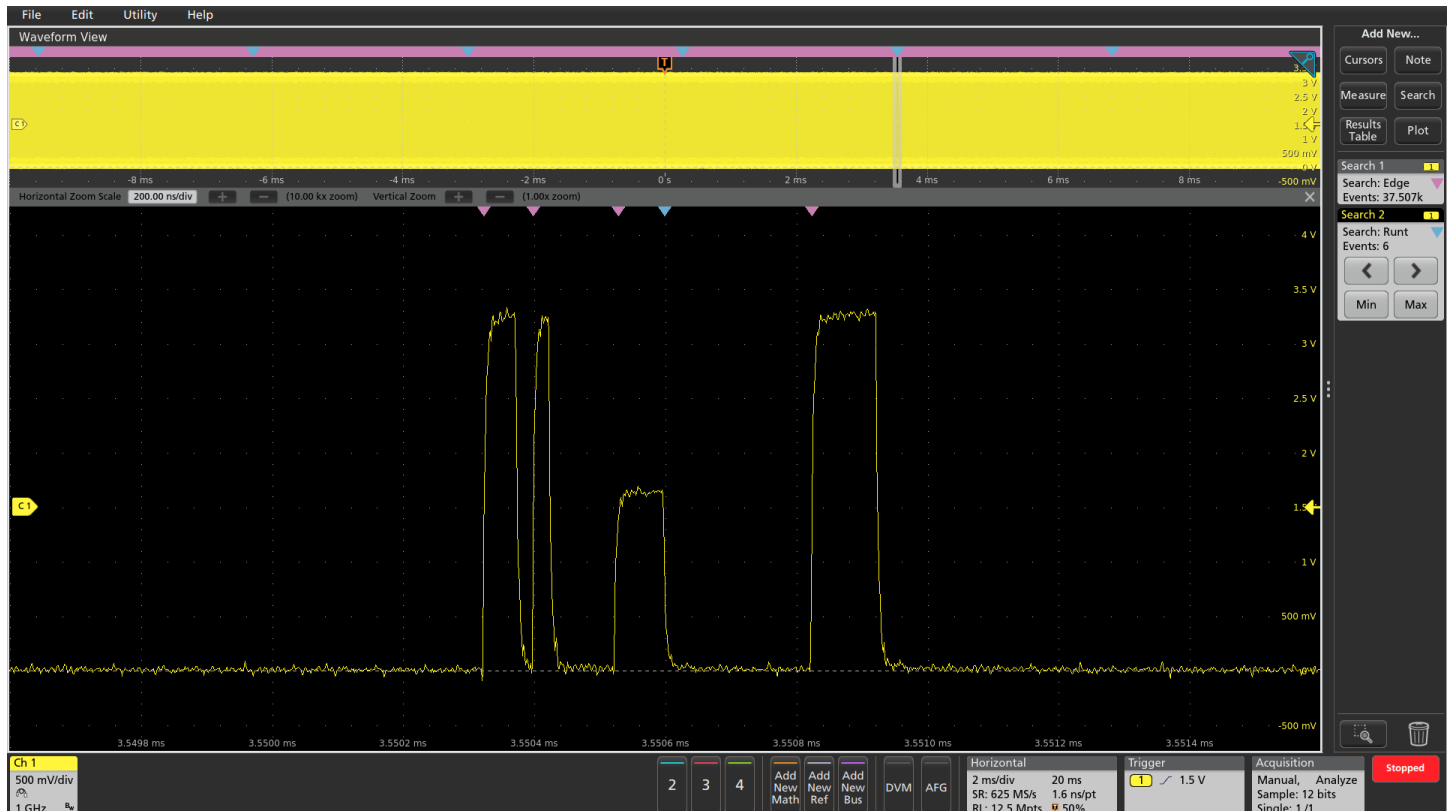
Navigation and search

Finding your event of interest in a long waveform record can be time consuming without the right search tools. With today's record lengths of many millions of data points, locating your event can mean scrolling through literally thousands of screens of signal activity.

The 6 Series MSO offers the industry's most comprehensive search and waveform navigation with its innovative Wave Inspector® controls. These controls speed panning and zooming through your record. With a unique force-feedback system, you can move from one end of your record to the other in just seconds. Or, use intuitive drag and pinch/expand gestures on the display itself to investigate areas of interest in a long record.

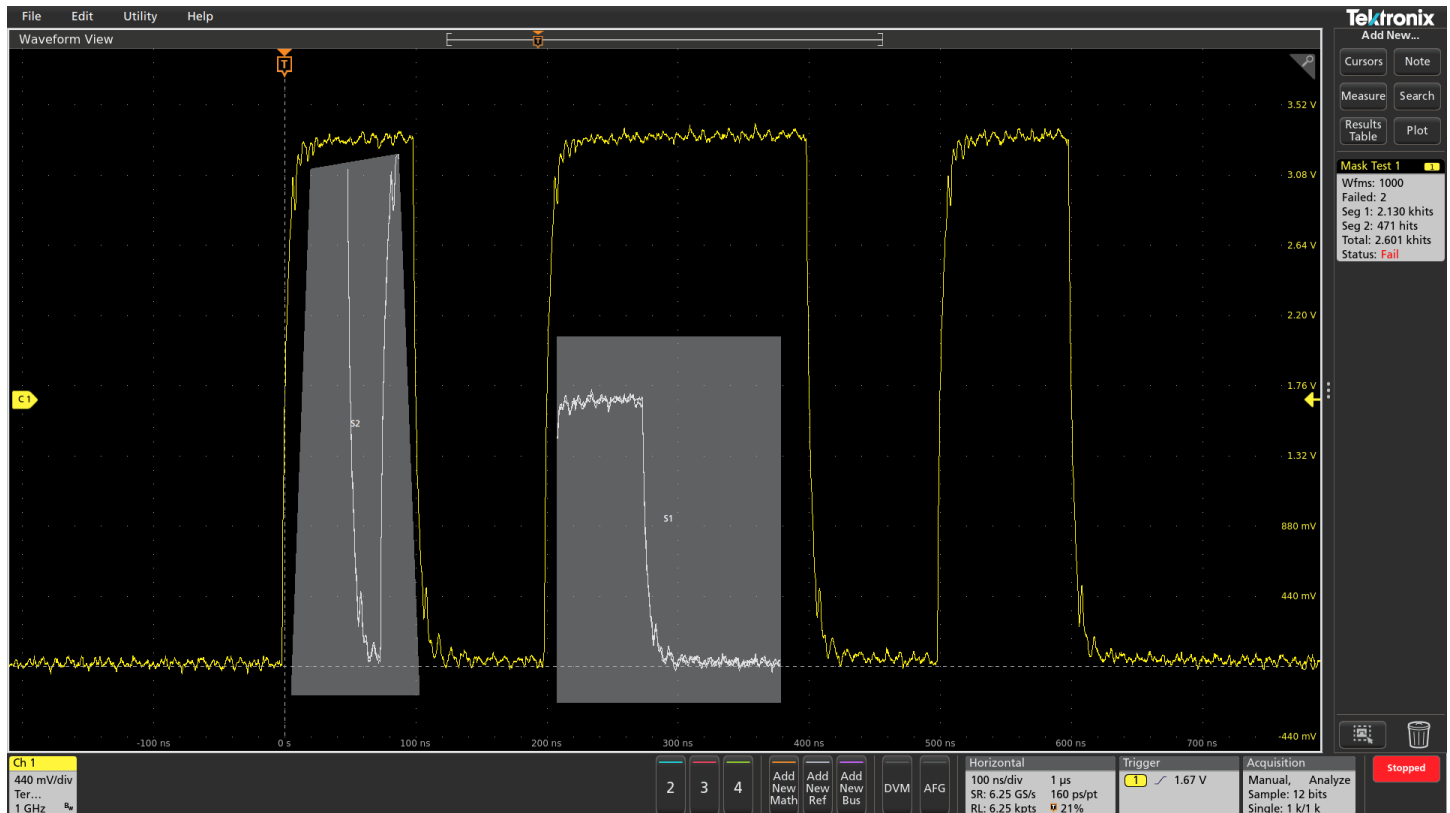
The Search feature allows you to automatically search through your long acquisition looking for user-defined events. All occurrences of the event are highlighted with search marks and are easily navigated to, using the Previous (←) and Next (→) buttons found on the front panel or on the Search badge on the display. Search types include edge, pulse width, timeout, runt, window, logic, setup and hold, rise/fall time and parallel/serial bus packet content. You can define as many unique searches as you like.

You can also quickly jump to the minimum and maximum value of search results by using the Min and Max buttons on the Search badge.



Earlier, FastAcq revealed the presence of a runt pulse in a digital data stream prompting further investigation.

Mask and limit testing (optional)



Custom, multiple segment mask capturing the presence of a signal glitch and runt pulse in a waveform.

Whether you are focused on signal integrity or setting up pass/fail conditions for production, mask testing is an efficient tool to characterize the behavior of certain signals in a system. Quickly create custom masks by drawing mask segments on the screen. Tailor a test to your specific requirements and set actions to take when a mask hit is registered, or when a complete test passes or fails.

Limit testing is an insightful way to monitor the long-term behavior of signals, helping you characterize a new design or confirm hardware performance during production line testing. Limit tests compare your live signal to an ideal, or golden version of the same signal with user-defined vertical and horizontal tolerances.

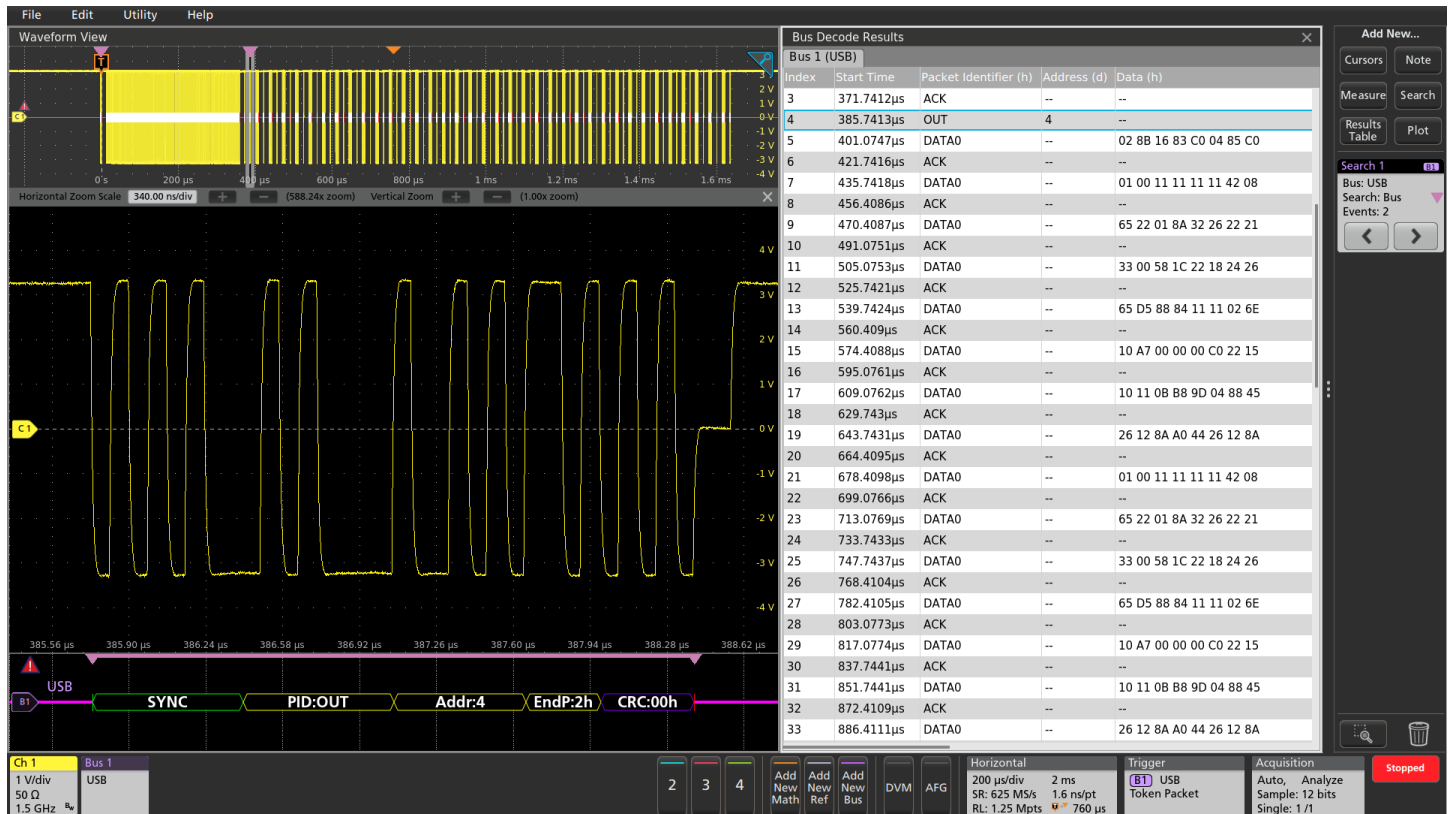
You can easily tailor a mask or limit test to your specific requirements by:

- Defining test duration in number of waveforms
- Setting a violation threshold that must be met before considering a test a failure
- Counting violations/failures and reporting statistical information
- Setting actions upon violations, test failure, and test complete

Serial protocol triggering and analysis (optional)

During debugging, it can be invaluable to trace the flow of activity through a system by observing the traffic on one or more serial buses. It could take many minutes to manually decode a single serial packet, much less the thousands of packets that may be present in a long acquisition.

And if you know the event of interest that you are attempting to capture occurs when a particular command is sent across a serial bus, wouldn't it be nice if you could trigger on that event? Unfortunately, it's not as easy as simply specifying an edge or a pulse width trigger.



Triggering on a USB full-speed serial bus. A bus waveform provides time-correlated decoded packet content including Start, Sync, PID, Address, End Point, CRC, Data values, and Stop, while the bus decode table presents all packet content from the entire acquisition.

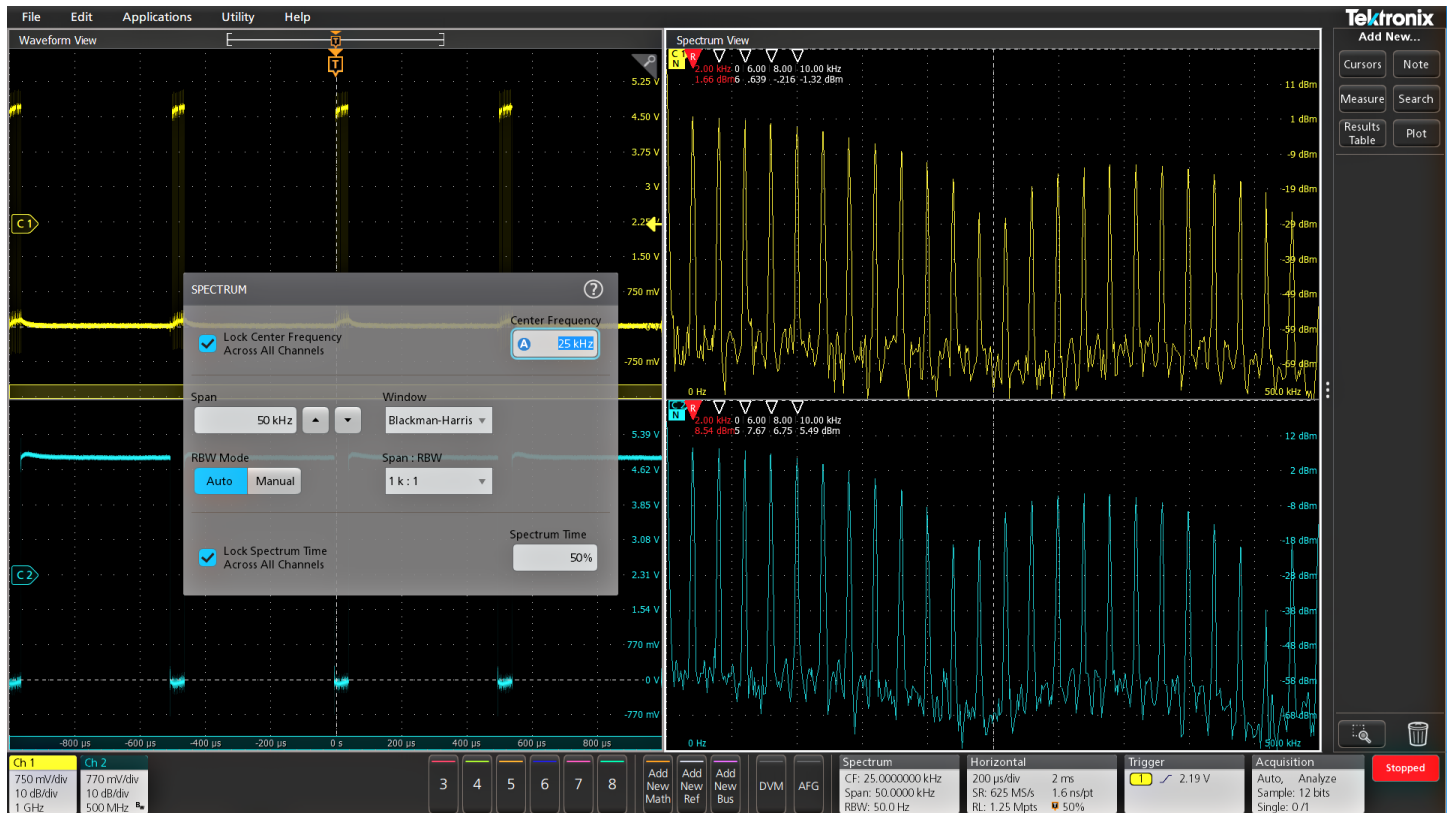
The 6 Series MSO offers a robust set of tools for working with the most common serial buses found in embedded design including I²C, SPI, I³C, RS-232/422/485/UART, SPMI, CAN, CAN FD, LIN, FlexRay, SENT, PSI5, Automotive Ethernet, USB LS/FS/HS, Ethernet 10/100, Audio (I²S/LJ/RJ/TDM), MIL-STD-1553, ARINC 429, NRZ Spacewire, 8B/10B, and NRZ.

Serial protocol search enables you to search through a long acquisition of serial packets and find the ones that contain the specific packet content you specify. Each occurrence is highlighted by a search mark. Rapid navigation between marks is as simple as pressing the Previous (←) and Next (→) buttons on the front panel or in the Search badge that appears in the Results Bar.

The tools described for serial buses also work on parallel buses. Support for parallel buses is standard in the 6 Series MSO. Parallel buses can be up to 32 bits wide and can include a combination of analog and digital channels.

- Serial protocol triggering lets you trigger on specific packet content including start of packet, specific addresses, specific data content, unique identifiers, and errors.
- Bus waveforms provide a higher-level, combined view of the individual signals (clock, data, chip enable, and so on) that make up your bus, making it easy to identify where packets begin and end, and identifying sub-packet components such as address, data, identifier, CRC, and so on.
- The bus waveform is time aligned with all other displayed signals, making it easy to measure timing relationships across various parts of the system under test.
- Bus decode tables provide a tabular view of all decoded packets in an acquisition much like you would see in a software listing. Packets are time stamped and listed consecutively with columns for each component (Address, Data, and so on).

Spectrum View



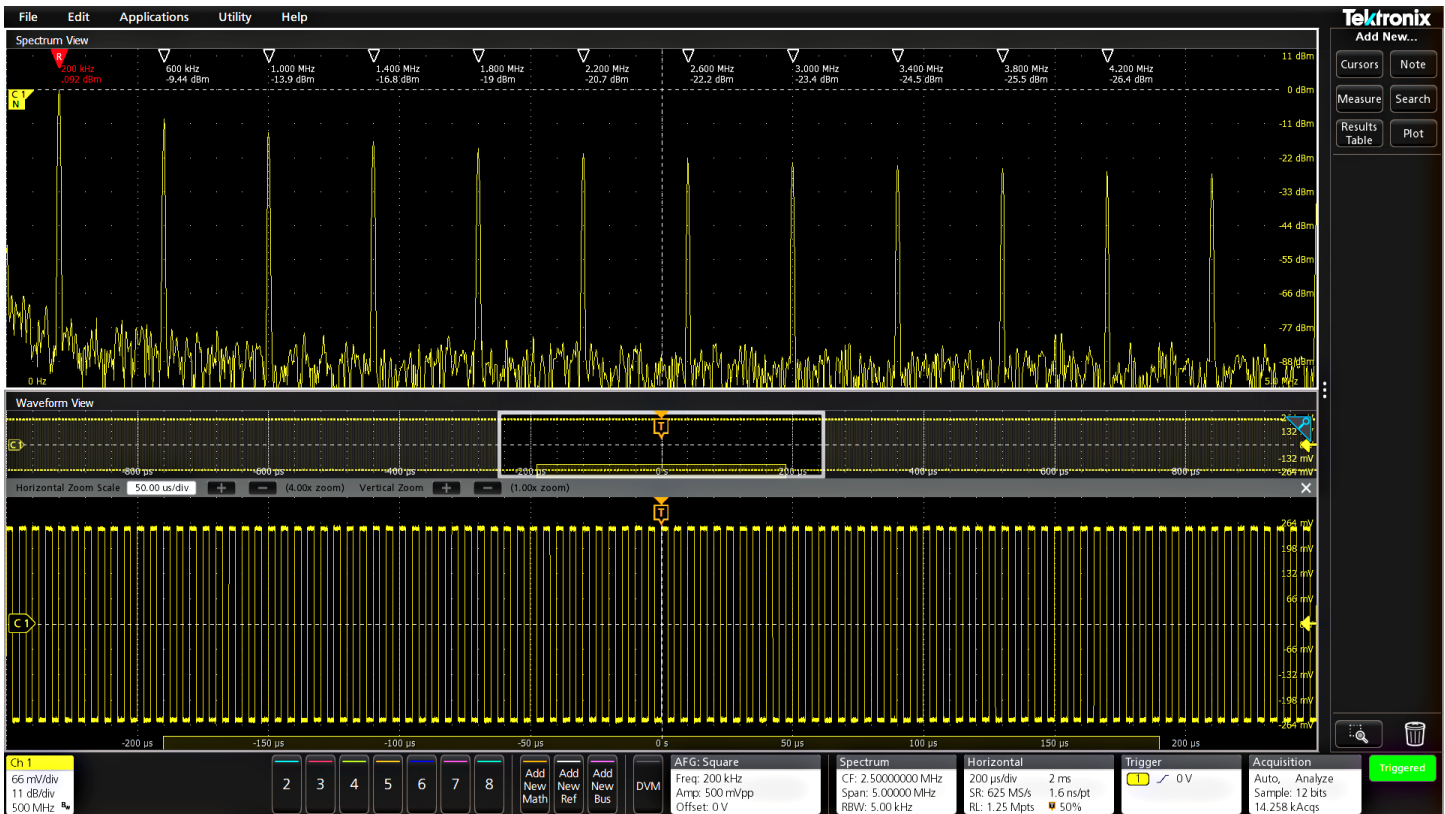
Intuitive spectrum analyzer controls like center frequency, span and resolution bandwidth (RBW), independent from time domain controls, provide easy setup for frequency domain analysis. A spectrum view is available for each FlexChannel analog input, enabling multi-channel mixed domain analysis.

It is often easier to debug an issue by viewing one or more signals in the frequency domain. Oscilloscopes have included math-based FFTs for decades in an attempt to address this need. However, FFTs are notoriously difficult to use for two primary reasons.

First, when performing frequency-domain analysis, you think about controls like Center Frequency, Span, and Resolution Bandwidth (RBW), as you would typically find on a spectrum analyzer. But then you use an FFT, where you are stuck with traditional scope controls like sample rate, record length and time/div and have to perform all the mental translations to try to get the view you're looking for in the frequency-domain.

Second, FFTs are driven by the same acquisition system that's delivering the analog time-domain view. When you optimize acquisition settings for the analog view, your frequency-domain view isn't what you want. When you get the frequency-domain view you want, your analog view is not what you want. With math-based FFTs, it is virtually impossible to get optimized views in both domains.

Spectrum View changes all of this. Tektronix' patented technology provides both a decimator for the time-domain and a digital downconverter for the frequency-domain behind each FlexChannel. The two different acquisition paths let you simultaneously observe both time- and frequency-domain views of the input signal with independent acquisition settings for each domain. Other manufacturers offer various 'spectral analysis' packages that claim ease-of-use, but they all exhibit the limitations described above. Only Spectrum View provides both exceptional ease-of-use and the ability to achieve optimal views in both domains simultaneously.

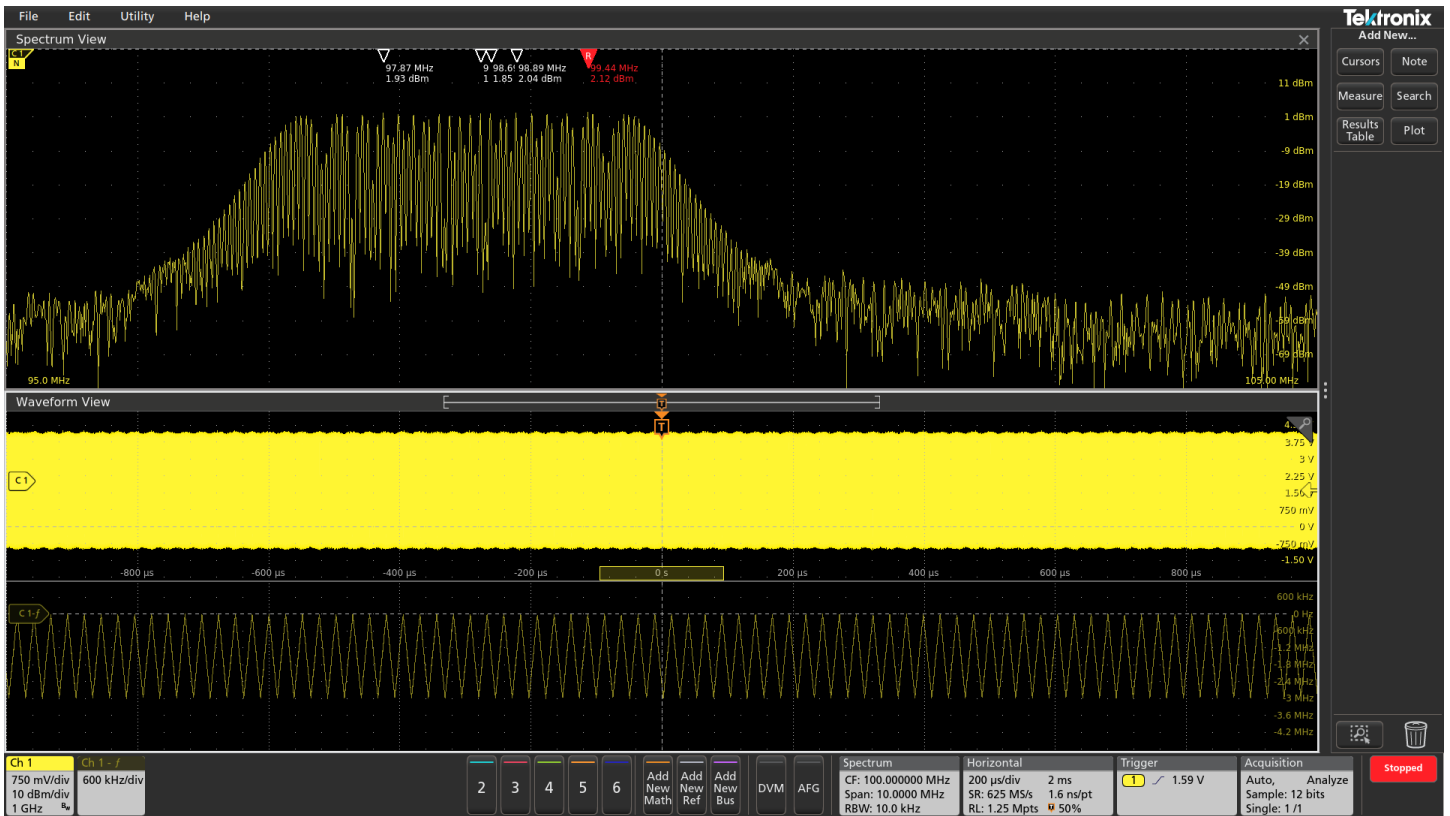


Spectrum Time gates the range of time where the FFT is being calculated. Represented by a small graphical rectangle in the time domain view, it can be positioned to provide time correlation with the time domain waveform. Perfect for conducting Mixed Domain Analysis. Up to 11 automated peak markers provide frequency and magnitude values of each peak. The Reference marker is always the highest peak shown and is indicated in red.

Visualizing changes in the RF signal – RF time domain traces make it easy to understand what's happening with a time-varying RF signal. There are three RF time domain traces that are derived from the underlying I and Q data of Spectrum View:

- Magnitude – The instantaneous amplitude of the spectrum vs. time.
- Frequency – The instantaneous frequency of the spectrum relative to the center frequency vs. time.
- Phase – The instantaneous phase of the spectrum relative to the center frequency vs. time.

Each of these traces can be turned on and off independently, and all three can be displayed simultaneously.



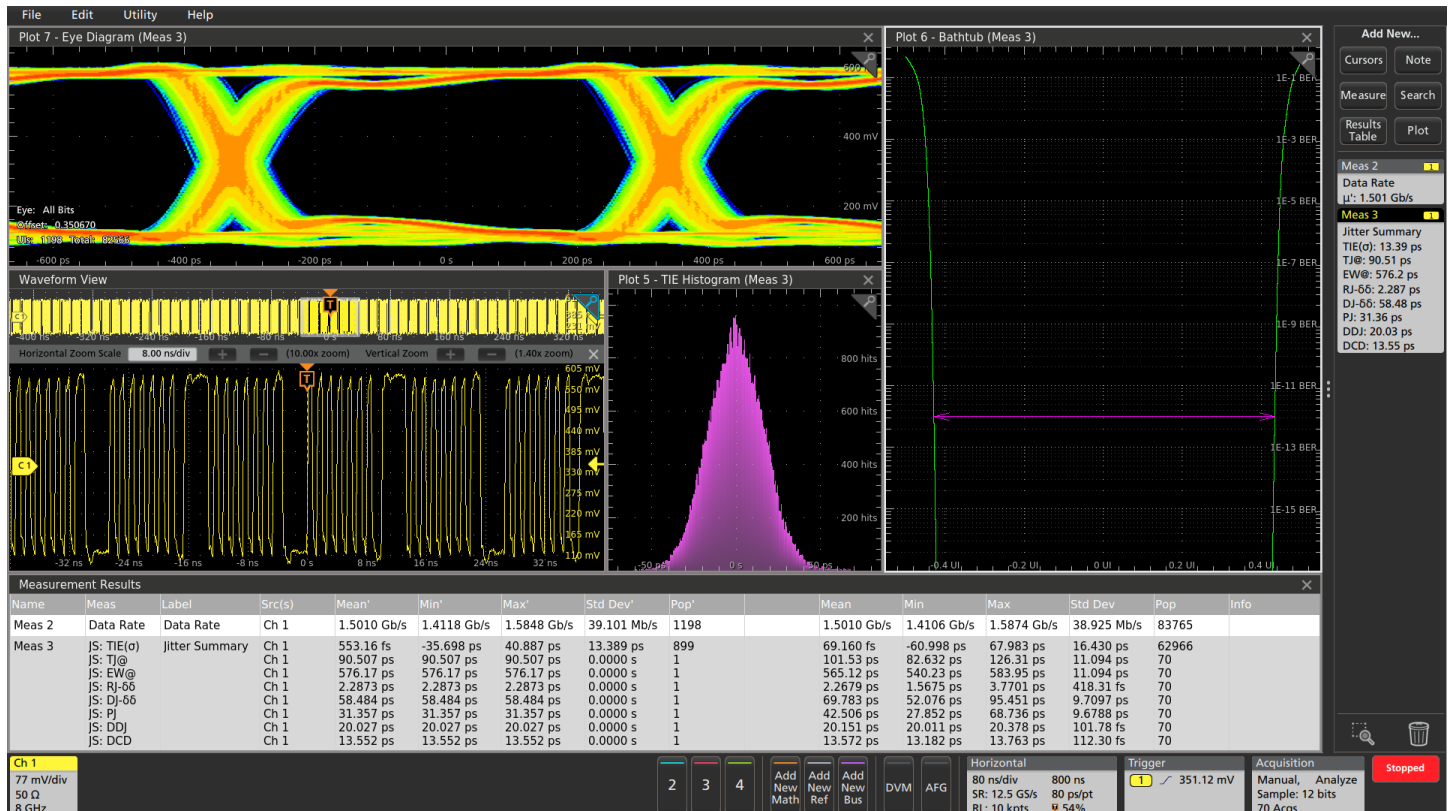
The lower trace is the frequency vs. time trace derived from the input signal. Notice that the Spectrum Time is positioned during a transition from the lowest frequency to the middle frequency, so the energy is spread across a number of frequencies. With the frequency vs. time trace, you can easily see the different frequency hops, simplifying characterization of how the device switches between frequencies.

Jitter analysis

The 6 Series MSO has seamlessly integrated the DPOJET Essentials jitter and eye pattern analysis software package, extending the oscilloscope's capabilities to take measurements over contiguous clock and data cycles in a single-shot real-time acquisition. This enables measurement of key jitter and timing analysis parameters such as Time Interval Error and Phase Noise to help characterize possible system timing issues.

Analysis tools, such as plots for time trends and histograms, quickly show how timing parameters change over time, and spectrum analysis quickly shows the precise frequency and amplitude of jitter and modulation sources.

Option 6-DJA adds additional jitter analysis capability to better characterize your device's performance. The 31 additional measurements provide comprehensive jitter and eye-diagram analysis and jitter decomposition algorithms, enabling the discovery of signal integrity issues and their related sources in today's high-speed serial, digital, and communication system designs. Option 6-DJA also provides eye diagram mask testing for automated pass/fail testing.



The unique Jitter Summary provides a comprehensive view of your device's performance in a matter of seconds.

Power analysis (optional)

The 6 Series MSO has also integrated the optional 6-PWR power analysis package into the oscilloscope's automatic measurement system to enable quick and repeatable analysis of power quality, input capacitance, in-rush current, harmonics, switching loss, safe operating area (SOA), modulation, ripple, magnetics measurements, efficiency, amplitude and timing measurements, slew rate (dv/dt and di/dt), Control Loop Response (Bode Plot), and Power Supply Rejection Ratio (PSRR).

Measurement automation optimizes the measurement quality and repeatability at the touch of a button, without the need for an external PC or complex software setup.



The Power Analysis measurements display a variety of waveforms and plots.

Compliance test

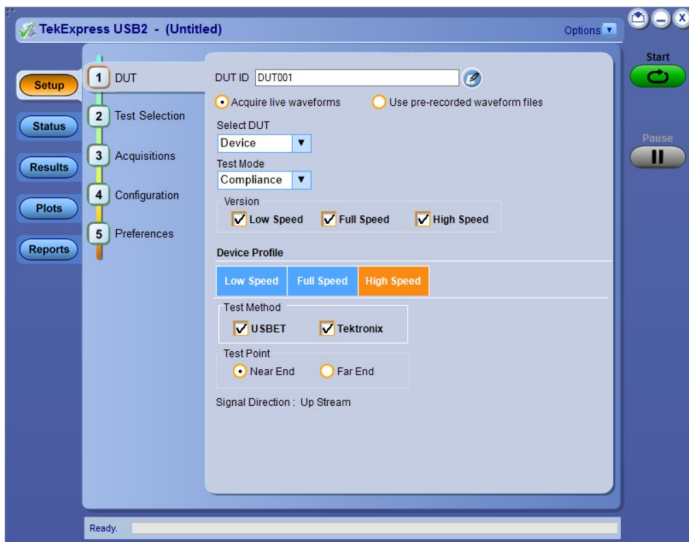
A key focus area for embedded designers is testing various embedded and interface technologies for compliance. This ensures the device passes the logo certification at plugfests and achieves successful interoperability when working with other compliant devices.

The compliance test specifications for high speed serial standards like USB, Ethernet, Memory, Display and MIPI are developed by the respective consortiums, or governing bodies. Working closely with these consortiums, Tektronix has developed oscilloscope-based compliance applications that not only focus on providing pass/fail results but also provide deeper insight into any failures by providing relevant measurement tools such as jitter and timing analysis to debug failing designs.

These automated compliance applications are built on a framework that provides:

- Complete test coverage per the specification.
- Fast test times with optimized acquisitions and test sequencing based on customized settings.

- Analysis based on previously-acquired signals, allowing the device under test (DUT) to be disconnected from the setup once all acquisitions are completed. This also allows analysis of waveforms acquired on a different oscilloscope or captured at a remote lab, facilitating a very collaborative test environment.
- Signal validation during acquisition to ensure the right signals are being captured.
- Additional parametric measurements for design debug.
- Custom eye diagram mask testing for insight into design margin.
- Detailed reports in multiple formats with setup information, results, margins, waveform screenshots and plot images.



TekExpress USB2 (Option 6-CMUSB2) DUT panel configures the DUT-specific settings



6 Series MSO running 6-CMUSB2 Compliance Measurements as per USB 2.0 Specification

Designed with your needs in mind

Connectivity

The 6 Series MSO contains a number of ports which you can use to connect the instrument to a network, directly to a PC, or to other test equipment.

- Two USB 2.0 and one USB 3.0 host ports on the front and four more USB host ports (two 2.0, two 3.0) on the rear panel enable easy transfer of screen shots, instrument settings, and waveform data to a USB mass storage device. A USB mouse and keyboard can also be attached to USB host ports for instrument control and data entry.
- The rear panel USB Device port is useful for controlling the oscilloscope remotely from a PC.
- The standard 10/100/1000BASE-T Ethernet port on the rear of the instrument enables easy connection to networks and provides LXI Core 2011 compatibility.
- DVI-D, Display Port and VGA ports on the rear of the instrument lets you duplicate the instrument display on an external monitor or projector.



The I/O you need to connect the 6 Series MSO to the rest of your design environment.

Remote operation to improve collaboration

Want to collaborate with a design team on the other side of the world?

The embedded e*Scope[®] capability enables fast control of the oscilloscope over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Control the oscilloscope remotely in the exact same way that you do in-person. Alternatively, you can use Microsoft Windows Remote Desktop™ capability to connect directly to your oscilloscope and control it remotely.

The industry-standard TekVISA™ protocol interface is included for using and enhancing Windows applications for data analysis and documentation. IVI-COM instrument drivers are included to enable easy communication with the oscilloscope using LAN or USBTMC connections from an external PC.



e*Scope provides simple remote viewing and control using common web browsers.

Arbitrary/Function Generator (AFG)

The instrument contains an optional integrated arbitrary/function generator, perfect for simulating sensor signals within a design or adding noise to signals to perform margin testing. The integrated function generator provides output of predefined waveforms up to 50 MHz for sine, square, pulse, ramp/triangle, DC, noise, sin(x)/x (Sinc), Gaussian, Lorentz, exponential rise/fall, Haversine and cardiac. The AFG can load waveform records up to 128 k points in size from an internal file location or a USB mass storage device.

The AFG feature is compatible with Tektronix' ArbExpress PC-based waveform creation and editing software, making creation of complex waveforms fast and easy.

Digital Voltmeter (DVM) and Trigger Frequency Counter

The instrument contains an integrated 4-digit digital voltmeter (DVM) and 8-digit trigger frequency counter. Any of the analog inputs can be a source for the voltmeter, using the same probes that are already attached for general oscilloscope usage. The trigger frequency counter provides a very precise readout of the frequency of the trigger event on which you're triggering.

Both the DVM and trigger frequency counter are available for free and are activated when you register your product.

Enhanced security option

The optional 6-SEC enhanced security option enables password-protected enabling/disabling of all instrument I/O ports and firmware upgrades. In addition, option 6-SEC provides the highest level of security by ensuring that internal memory never stores user settings or waveform data, in compliance with National Industrial Security Program Operating Manual (NISPOM) DoD 5220.22-M, Chapter 8 requirements and Defense Security Service Manual for the Certification and Accreditation of Classified Systems under the NISPOM. This ensures that you can confidently move the instrument out of a secure area.

Help when you need it

The 6 Series MSO includes several helpful resources so you can get your questions answered rapidly without having to find a manual or go to a website:

- Graphical images and explanatory text are used in numerous menus to provide quick feature overviews.
- All menus include a question mark icon in the upper right that takes you directly to the portion of the integrated help system that applies to that menu.
- A short user interface tutorial is included in the Help menu for new users to come up to speed on the instrument in a matter of a few minutes.

The screenshot displays the TekScope Help system integrated into the instrument's interface. The help window is titled "TEKSCOPE HELP" and features a "Contents" sidebar on the left with a tree view of topics. The main content area is titled "Add Measurements configuration menu overview" and contains several paragraphs of text explaining how to use the "Add Measurements" menu. Below the text is a table titled "Add Measurements menu fields and controls" with two columns: "Field or control" and "Description". The table lists "Measurement tabs" and "Measurement description". To the right of the help window is the "ADD MEASUREMENTS" configuration panel, which shows a waveform with an amplitude measurement line and various measurement options like Amplitude, Peak-to-Peak, Mean, Top, Maximum, Positive Overshoot, RMS, Base, Minimum, Negative Overshoot, AC RMS, and Area. The bottom of the screen shows the instrument's control panel with various settings like Channel 1, Horizontal, Trigger, and Acquisition.

| Field or control | Description |
|--------------------------------|---|
| Measurement tabs | The tabs along the top organize measurements by their type. The Standard tab is the default set of measurements that are built in to the instrument. Other tabs are shown when you install measurement options. |
| Measurement description | Shows a graphic and short description of the selected measurement. Use this information to verify that the selected measurement is |

Integrated help answers your questions rapidly without having to find a manual or go to the internet.

Specifications

All specifications are guaranteed unless noted otherwise. All specifications apply to all models unless noted otherwise.

Model overview

Oscilloscope

| | MSO64 |
|---|--|
| FlexChannel inputs | 4 |
| Maximum analog channels | 4 |
| Maximum digital channels (with optional logic probes) | 32 |
| Bandwidth (calculated rise time) | 1 GHz (400 ps), 2.5 GHz (160 ps), 4 GHz (100 ps), 6 GHz (66.67 ps), 8 GHz (50 ps) |
| DC Gain Accuracy | 50 Ω: ±2.0% ⁴ at >2 mV/div (±2.0% at 2 mV/div typical, ±4% at 1 mV/div typical) 50 Ω: ±1.0% ⁵ of full scale at >2 mV/div, (±1.0% of full scale at 2 mV/div typical, ±2% at 1 mV/div typical) 1 MΩ: ±2.0% ⁴ at >2 mV/div (±2% at 2 mV/div, ±2.5% at 1 mV/div typical and 500 μV/div typical) 1 MΩ: ±1.0% ⁵ of full scale at >2 mV/div, (±1.0% of full scale at 2 mV/div typical, ±1.25% at 1 mV/div and 500 μV/div, typical) |
| ADC Resolution | 12 bits |
| Vertical Resolution | 8 bits @ 25 GS/s; 8 GHz on all channels 12 bits @ 12.5 GS/s; 4 GHz on all channels 13 bits @ 6.25 GS/s (High Res); 2 GHz on all channels 14 bits @ 3.125 GS/s (High Res); 1 GHz on all channels 15 bits @ 1.25 GS/s (High Res); 500 MHz on all channels 16 bits @ ≤625 MS/s (High Res); 200 MHz on all channels |
| Sample Rate | 25 GS/s on all analog / digital channels (40 ps resolution) |
| Record Length | 62.5 Mpoints on all analog / digital channels, 125 Mpoints on all analog / digital channels optional, and 250 Mpoints on all analog / digital channels optional |
| Waveform Capture Rate | >500,000 wfms/s (Peak Detect, Envelope acquisition mode), >30,000 wfms/s (all other acquisition modes) |
| Arbitrary/Function Generator (opt.) | 13 predefined waveform types with up to 50 MHz output |
| DVM | 4-digit DVM (free with product registration) |
| Trigger Frequency Counter | 8-digit frequency counter (free with product registration) |

Vertical system - analog channels

Input coupling DC, AC

Input impedance 1 MΩ DC coupled 1 MΩ ±1%

Input capacitance 1 MΩ DC coupled, typical 14.5 pF ±1.5 pF

Input impedance 50 Ω, DC coupled 50 Ω ±3%

Input sensitivity range

1 MΩ 500 μV/div to 10 V/div in a 1-2-5 sequence
Note: 500 μV/div is a 2X digital zoom of 1 mV/div.

⁴ Immediately after SPC, add 2% for every 5 °C change in ambient.

⁵ Immediately after SPC, add 1% for every 5 °C change in ambient.

Vertical system - analog channels50 Ω

1 mV/div to 1 V/div in a 1-2-5 sequence

Note: 1 mV/div is a 2X digital zoom of 2 mV/div.

Maximum input voltage50 Ω : 2.5 V_{RMS} at <100 mV/div, with peaks $\leq \pm 20$ V (DF $\leq 6.25\%$)50 Ω : 5 V_{RMS} at ≥ 100 mV/div, with peaks $\leq \pm 20$ V (DF $\leq 6.25\%$)1 M Ω : 300 V_{RMS} For 1 M Ω , derate at 20 dB/decade from 4.5 MHz to 45 MHz;Derate at 14 dB/decade from 45 MHz to 450 MHz; > 450 MHz, 5.5 V_{RMS} **Effective bits (ENOB), typical**2 mV/div, High Res mode,
50 Ω , 10 MHz input with 90%
full screen

| Bandwidth | ENOB |
|-----------|------|
| 4 GHz | 5.9 |
| 3 GHz | 6.1 |
| 2.5 GHz | 6.2 |
| 2 GHz | 6.35 |
| 1 GHz | 6.8 |
| 500 MHz | 7.2 |
| 350 MHz | 7.4 |
| 250 MHz | 7.5 |
| 200 MHz | 7.75 |
| 20 MHz | 8.8 |

50 mV/div, High Res mode,
50 Ω , 10 MHz input with 90%
full screen

| Bandwidth | ENOB |
|-----------|------|
| 4 GHz | 7.25 |
| 3 GHz | 7.5 |
| 2.5 GHz | 7.6 |
| 2 GHz | 7.8 |
| 1 GHz | 8.2 |
| 500 MHz | 8.5 |
| 350 MHz | 8.8 |
| 250 MHz | 8.9 |
| 200 MHz | 9 |
| 20 MHz | 9.8 |

Vertical system - analog channels

2 mV/div, Sample mode, 50 Ω,
10 MHz input with 90% full
screen

| Bandwidth | ENOB |
|-----------|------|
| 8 GHz | 5.1 |
| 7 GHz | 5.3 |
| 6 GHz | 5.5 |
| 5 GHz | 5.65 |
| 4 GHz | 5.9 |
| 3 GHz | 6.05 |
| 2.5 GHz | 6.2 |
| 2 GHz | 6.35 |
| 1 GHz | 6.8 |
| 500 MHz | 7.2 |
| 350 MHz | 7.3 |
| 250 MHz | 7.5 |
| 200 MHz | 7.3 |
| 20 MHz | 7.6 |

50 mV/div, Sample mode,
50 Ω, 10 MHz input with 90%
full screen

| Bandwidth | ENOB |
|-----------|------|
| 8 GHz | 6.5 |
| 7 GHz | 6.6 |
| 6 GHz | 6.8 |
| 5 GHz | 7 |
| 4 GHz | 7.2 |
| 3 GHz | 7.4 |
| 2.5 GHz | 7.6 |
| 2 GHz | 7.7 |
| 1 GHz | 8.2 |
| 500 MHz | 8.4 |
| 350 MHz | 8.7 |
| 250 MHz | 8.8 |
| 200 MHz | 7.8 |
| 20 MHz | 7.9 |

DC balance

0.1 div with DC-50 Ω oscilloscope input impedance (50 Ω BNC terminated)
0.2 div at 1 mV/div with DC-50 Ω oscilloscope input impedance (50 Ω BNC terminated)
0.2 div with DC-1 MΩ oscilloscope input impedance (50 Ω BNC terminated)

Position range

±5 divisions

Vertical system - analog channels

Offset ranges, maximum

Input signal cannot exceed maximum input voltage for the 50 Ω input path.

| Volts/div Setting | Maximum offset range, 50 Ω Input |
|----------------------|---|
| 1 mV/div - 99 mV/div | ± 1 V |
| 100 mV/div - 1 V/div | ± 10 V |

| Volts/div Setting | Maximum offset range, 1 M Ω Input |
|-----------------------------|--|
| 500 μ V/div - 63 mV/div | ± 1 V |
| 64 mV/div - 999 mV/div | ± 10 V |
| 1 V/div - 10 V/div | ± 100 V |

Offset accuracy $\pm(0.005 \times |\text{offset} - \text{position}| + \text{DC balance})$; Offset, position, and DC Balance in units of Volts

Bandwidth selections

| | |
|------------------------------|---|
| 8 GHz model, 50 Ohm | 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, 4 GHz, 5 GHz, 6 GHz, 7 GHz, and 8 GHz |
| 6 GHz model, 50 Ohm | 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, 4 GHz, 5 GHz, and 6 GHz |
| 4 GHz model, 50 Ohm | 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, and 4 GHz |
| 2.5 GHz model, 50 Ohm | 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, and 2.5 GHz |
| 1 GHz model, 50 Ohm | 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, and 1 GHz |
| 1M Ohm | 20 MHz, 200 MHz, 250 MHz, 350 MHz, and Full (500 MHz) |

Bandwidth filtering optimized for Flatness or Step response

Vertical system - analog channels

Random noise, RMS, typical

50 Ω, typical

25 GS/s, Sample Mode, RMS

| V/div | 1 mV/div | 2 mV/div | 5 mV/div | 10 mV/div | 20 mV/div | 50 mV/div | 100 mV/div | 1 V/div |
|-------|----------|----------|----------|-----------|-----------|-----------|------------|---------|
| 8 GHz | 158 μV | 158 μV | 208 μV | 342 μV | 630 μV | 1.49 mV | 3.46 mV | 29.7 mV |
| 7 GHz | 141 μV | 143 μV | 192 μV | 311 μV | 562 μV | 1.31 mV | 3.11 mV | 26.2 mV |
| 6 GHz | 127 μV | 127 μV | 165 μV | 274 μV | 489 μV | 1.18 mV | 2.71 mV | 23.6 mV |
| 5 GHz | 112 μV | 113 μV | 149 μV | 239 μV | 446 μV | 1.05 mV | 2.42 mV | 21.1 mV |

12.5 GS/s, HiRes Mode, RMS

| V/div | 1 mV/div | 2 mV/div | 5 mV/div | 10 mV/div | 20 mV/div | 50 mV/div | 100 mV/div | 1 V/div |
|---------|----------|----------|----------|-----------|-----------|-----------|------------|---------|
| 4 GHz | 97.4 μV | 98.7 μV | 124 μV | 192 μV | 344 μV | 817 μV | 1.92 mV | 16.3 mV |
| 3 GHz | 82.9 μV | 84 μV | 105 μV | 160 μV | 282 μV | 680 μV | 1.62 mV | 13.6 mV |
| 2.5 GHz | 76.5 μV | 77.5 μV | 93.8 μV | 144 μV | 257 μV | 606 μV | 1.44 mV | 12.1 mV |
| 2 GHz | 68.1 μV | 69.1 μV | 83.6 μV | 131 μV | 226 μV | 528 μV | 1.28 mV | 10.6 mV |
| 1 GHz | 54.8 μV | 51.2 μV | 63.4 μV | 90.9 μV | 160 μV | 378 μV | 941 μV | 7.65 mV |
| 500 MHz | 39.7 μV | 39.8 μV | 48.1 μV | 65.1 μV | 115 μV | 280 μV | 666 μV | 5.6 mV |
| 350 MHz | 33.8 μV | 33.5 μV | 40 μV | 54.8 μV | 94.3 μV | 217 μV | 560 μV | 4.35 mV |
| 250 MHz | 30.8 μV | 31.2 μV | 36.1 μV | 49.9 μV | 80.3 μV | 187 μV | 482 μV | 3.75 mV |
| 200 MHz | 25.3 μV | 25.4 μV | 29.7 μV | 44 μV | 70.7 μV | 165 μV | 445 μV | 3.3 mV |
| 20 MHz | 8.68 μV | 8.9 μV | 10.4 μV | 15.1 μV | 27.5 μV | 70.4 μV | 158 μV | 1.41 mV |

1 MΩ, High Res mode (RMS), typical

| V/div | 1 mV/div | 2 mV/div | 5 mV/div | 10 mV/div | 20 mV/div | 50 mV/div | 100 mV/div | 1 V/div |
|---------|----------|----------|----------|-----------|-----------|-----------|------------|---------|
| 500 MHz | 186 μV | 202 μV | 210 μV | 236 μV | 288 μV | 522 μV | 1.25 mV | 13.4 mV |
| 350 MHz | 134 μV | 138 μV | 145 μV | 163 μV | 216 μV | 391 μV | 974 μV | 10.6 mV |
| 250 MHz | 108 μV | 110 μV | 114 μV | 131 μV | 182 μV | 374 μV | 838 μV | 9.63 mV |
| 200 MHz | 106 μV | 108 μV | 109 μV | 117 μV | 149 μV | 274 μV | 674 μV | 8.01 mV |
| 20 MHz | 73 μV | 73.2 μV | 78.1 μV | 99.6 μV | 158 μV | 361 μV | 801 μV | 8.29 mV |

Crosstalk (channel isolation), typical

≥70 dB up to 2 GHz
 ≥60 dB up to 5 GHz
 ≥45 dB up to 8 GHz
 for any two channels set to 200 mV/div.

Vertical system - digital channels

| | |
|---|--|
| Number of channels | 8 digital inputs (D7-D0) per installed TLP058 (traded off for one analog channel) |
| Vertical resolution | 1 bit |
| Maximum input toggle rate | 500 MHz |
| Minimum detectable pulse width, typical | 1 ns |
| Thresholds | One threshold per digital channel |
| Threshold range | ± 40 V |
| Threshold resolution | 10 mV |
| Threshold accuracy | $\pm [100 \text{ mV} + 3\% \text{ of threshold setting after calibration}]$ |
| Input hysteresis, typical | 100 mV at the probe tip |
| Input dynamic range, typical | 30 V _{pp} for F _{in} ≤ 200 MHz, 10 V _{pp} for F _{in} > 200 MHz |
| Absolute maximum input voltage, typical | ± 42 V peak |
| Minimum voltage swing, typical | 400 mV peak-to-peak |
| Input impedance, typical | 100 k Ω |
| Probe loading, typical | 2 pF |

Horizontal system

| | |
|---------------------|--|
| Time base range | 40 ps/div to 1,000 s/div |
| Sample rate range | 6.25 S/s to 25 GS/s (real time) 50 GS/s to 2.5 TS/s (interpolated) |
| Record length range | Applies to analog and digital channels. All acquisition modes are 250 M maximum record length, down to 1 k minimum record length, adjustable in 1 sample increments. Standard: 62.5 Mpoints Option 6-RL-1: 125 Mpoints Option 6-RL-2: 250 Mpoints |

| Seconds/Division range | Model | 1 K | 10 K | 100 K | 1 M | 10 M | 62.5 M | 125 M | 250 M |
|------------------------|-------------------------------|-----------------|-------------------|---------------|-----|------|-------------------------|-----------------------|------------------------|
| | MSO64 Standard 62.5 M | 40 ps - 16 s | 400 ps - 160 s | 4 ns - 1000 s | | | 2.5 μ s - 1000 s | N/A | N/A |
| | MSO64 Option 6- RL-1 125 M | 40 ps - 16 s | 400 ps - 160 s | 4 ns - 1000 s | | | 2.5 μ s - 1000 s | 5 μ s - 1000 s | N/A |
| | MSO64 Option 6- RL-2 250 M | 40 ps - 16 s | 400 ps - 160 s | 4 ps - 1000 s | | | 2.5 μ s - 1000 s | 5 μ s - 1000 s | 10 μ s - 1000 s |

Horizontal system

| | | |
|--------------------------------------|----------------------|-----------------------|
| Aperture uncertainty (sample jitter) | Time duration | Typical jitter |
| | <1 μs | 80 fs |
| | <1 ms | 130 fs |

Timebase accuracy ±1.0 x10⁻⁷ over any ≥1 ms time interval

| Description | Specification |
|-----------------------|---|
| Factory Tolerance | ±12 ppb At calibration, 25 °C ambient, over any ≥1 ms interval |
| Temperature stability | ±20 ppb across the full operating range of 0 °C to 50 °C, after a sufficient soak time at the temperature Tested at operating temperatures |
| Crystal aging | ±300 ppb. Frequency tolerance change at 25 °C over a period of 1 year |

Delta-time measurement accuracy, nominal

$$DTA_{pp}(\text{typical}) = 10 \times \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + \left(0.450 \text{ ps} + \left(1 \times 10^{-11} \times t_p\right)\right)^2} + TBA \times t_p$$

$$DTA_{RMS} = \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + \left(0.450 \text{ ps} + \left(1 \times 10^{-11} \times t_p\right)\right)^2} + TBA \times t_p$$

(assume edge shape that results from Gaussian filter response)

The formula to calculate delta-time measurement accuracy (DTA) for a given instrument setting and input signal assumes insignificant signal content above Nyquist frequency, where:

SR₁ = Slew Rate (1st Edge) around 1st point in measurement

SR₂ = Slew Rate (2nd Edge) around 2nd point in measurement

N = input-referred guaranteed noise limit (V_{RMS})

TBA = timebase accuracy or Reference Frequency Error

t_p = delta-time measurement duration (sec)

| | |
|--|--|
| Maximum duration at highest sample rate | 2.5 ms (std.) or 5 ms (opt. 6-RL-1, 125 Mpoints) or 10 ms (opt. 6-RL-2, 250 Mpoints) |
| Time base delay time range | -10 divisions to 5,000 s |
| Deskew range | -125 ns to +125 ns with a resolution of 40 ps (for Peak Detect and Envelope acquisition modes). -125 ns to +125 ns with a resolution of 1 ps (for all other acquisition modes). |
| Delay between analog channels, full bandwidth, typical | ≤ 10 ps for any two channels with input impedance set to 50 Ω, DC coupling with equal Volts/div or above 10 mV/div |
| Delay between analog and digital FlexChannels, typical | < 1 ns when using a TLP058 and a passive probe matching the bandwidth of the scope, with no bandwidth limits applied |
| Delay between any two digital FlexChannels, typical | 320 ps |
| Delay between any two bits of a digital FlexChannel, typical | 160 ps |

Trigger system

Trigger modes Auto, Normal, and Single

Trigger coupling DC, HF Reject (attenuates > 50 kHz), LF Reject (attenuates < 50 kHz), noise reject (reduces sensitivity)

Trigger bandwidth (edge, pulse and logic), typical

| Model | Trigger type | Trigger bandwidth |
|------------------------------|--------------------|-------------------|
| MSO64 8 GHz | Edge | 8 GHz |
| MSO64 8 GHz | Pulse, Logic | 4 GHz |
| MSO64 6 GHz | Edge | 6 GHz |
| MSO64 6 GHz | Pulse, Logic | 4 GHz |
| MSO64 4 GHz, 2.5 GHz, 1 GHz: | Edge, Pulse, Logic | Product Bandwidth |

Edge-type trigger sensitivity, DC coupled, typical

| Path | Range | Specification |
|--------------------------------|---|--|
| 1 M Ω path (all models) | 0.5 mV/div to 0.99 mV/div | 5 mV from DC to instrument bandwidth |
| | ≥ 1 mV/div | The greater of 5 mV or 0.7 div from DC to lesser of 500 MHz or instrument BW, & 6 mV or 0.8 div from > 500 MHz to instrument bandwidth |
| 50 Ω path | 1 mV/div to 9.98 mV/div | 3.0 div from DC to instrument bandwidth |
| | ≥ 10 mV/div | < 1.0 division from DC to instrument bandwidth |
| Line | 90 V to 264 V line voltage at 50 - 60 Hz line frequency | 103.5 V to 126.5 V |
| AUX Trigger in | | 250 mV _{pp} , DC to 400 MHz |

Edge-type trigger sensitivity, not DC coupled, typical

| Trigger Coupling | Typical Sensitivity |
|------------------|--|
| NOISE REJ | 2.5 times the DC Coupled limits |
| HF REJ | 1.0 times the DC Coupled limits from DC to 50 kHz. Attenuates signals above 50 kHz. |
| LF REJ | 1.5 times the DC Coupled limits for frequencies above 50 kHz. Attenuates signals below 50 kHz. |

Trigger jitter, typical

≤ 1.5 ps_{RMS} for sample mode and edge-type trigger
 ≤ 7 ps_{RMS} ≤ 2 ps_{RMS} for edge-type trigger and FastAcq mode
 ≤ 40 ps_{RMS} for non edge-type trigger modes
 ≤ 40 ps_{RMS} for AUX trigger in, Sample acquisition mode, edge trigger
 ≤ 40 ps_{RMS} for AUX trigger in, FastAcq acquisition mode, edge trigger

Trigger jitter, AUX input, typical

≤ 200 ps_{RMS} for sample mode and edge-type trigger
 ≤ 220 ps_{RMS} for edge-type trigger and FastAcq mode

AUX In trigger skew between instruments, typical

± 100 ps jitter on each instrument with 1.5 ns skew; ≤ 1.7 ns total between instruments. With manual deskewing of individual channels, total instrument skew can reach 200ps between different instrument channels.
 Skew improves for pulse input voltages ≥ 1 V_{pp}

Trigger system

Trigger level ranges

| Source | Range |
|----------------|------------------------------------|
| Any Channel | ±5 divs from center of screen |
| Aux In Trigger | ±5 V |
| Line | Fixed at about 50% of line voltage |

This specification applies to logic and pulse thresholds.

Trigger frequency counter

8-digits (free with product registration)

Trigger types

| | |
|---|---|
| Edge: | Positive, negative, or either slope on any channel. Coupling includes DC, AC, noise reject, HF reject, and LF reject |
| Pulse Width: | Trigger on width of positive or negative pulses. Event can be time- or logic-qualified |
| Timeout: | Trigger on an event which remains high, low, or either, for a specified time period. Event can be logic-qualified |
| Runt: | Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again. Event can be time- or logic-qualified |
| Window: | Trigger on an event that enters, exits, stays inside or stays outside of a window defined by two user-adjustable thresholds. Event can be time- or logic-qualified |
| Logic: | Trigger when logic pattern goes true, goes false, or occurs coincident with a clock edge. Pattern (AND, OR, NAND, NOR) specified for all input channels defined as high, low, or don't care. Logic pattern going true can be time-qualified |
| Setup & Hold: | Trigger on violations of both setup time and hold time between clock and data present on any input channels |
| Rise / Fall Time: | Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either. Event can be logic-qualified |
| Video (option 6-VID): | Trigger on all lines, odd, even, or all fields of NTSC, PAL, and SECAM video signals |
| Sequence: | Trigger on B event X time or N events after A trigger with a reset on C event. In general, A and B trigger events can be set to any trigger type with a few exceptions: logic qualification is not supported, if A event or B event is set to Setup & Hold, then the other must be set to Edge, and Ethernet and High Speed USB (480 Mbps) are not supported |
| Visual trigger | Qualifies standard triggers by scanning all waveform acquisitions and comparing them to on-screen areas (geometric shapes). An unlimited number of areas can be defined with In, Out, or Don't Care as the qualifier for each area. A boolean expression can be defined using any combination of visual trigger areas to further qualify the events that get stored into acquisition memory. Shapes include rectangle, triangle, trapezoid, hexagon and user-defined. |
| Parallel Bus: | Trigger on a parallel bus data value. Parallel bus can be from 1 to 32 bits (from the digital and analog channels) in size. Supports Binary and Hex radices |
| I²C Bus (option 6-SREMBD): | Trigger on Start, Repeated Start, Stop, Missing ACK, Address (7 or 10 bit), Data, or Address and Data on I ² C buses up to 10 Mb/s |
| SPI Bus (option 6-SREMBD): | Trigger on Slave Select, Idle Time, or Data (1-16 words) on SPI buses up to 20 Mb/s |
| RS-232/422/485/UART Bus (option 6-SRCOMP): | Trigger on Start Bit, End of Packet, Data, and Parity Error up to 15 Mb/s |
| CAN Bus (option 6-SRAUTO): | Trigger on Start of Frame, Type of Frame (Data, Remote, Error, or Overload), Identifier, Data, Identifier and Data, End Of Frame, Missing Ack, and Bit Stuff Error on CAN buses up to 1 Mb/s |
| CAN FD Bus (option 6-SRAUTO): | Trigger on Start of Frame, Type of Frame (Data, Remote, Error, or Overload), Identifier (Standard or Extended), Data (1-8 bytes), Identifier and Data, End Of Frame, Error (Missing Ack, Bit Stuffing Error, FD Form Error, Any Error) on CAN FD buses up to 16 Mb/s |
| LIN Bus (option 6-SRAUTO): | Trigger on Sync, Identifier, Data, Identifier and Data, Wakeup Frame, Sleep Frame, and Error on LIN buses up to 1 Mb/s |
| FlexRay Bus (option 6-SRAUTO): | Trigger on Start of Frame, Indicator Bits (Normal, Payload, Null, Sync, Startup), Frame ID, Cycle Count, Header Fields (Indicator Bits, Identifier, Payload Length, Header CRC, and Cycle Count), Identifier, Data, Identifier and Data, End Of Frame, and Errors on FlexRay buses up to 10 Mb/s |
| SENT Bus (option 6-SRAUTOSEN) | Trigger on Start of Packet, Fast Channel Status and Data, Slow Channel Message ID and Data, and CRC Errors |
| SPMI Bus (option 6-SRPM): | Trigger on Sequence Start Condition, Reset, Sleep, Shutdown, Wakeup, Authenticate, Master Read, Master Write, Register Read, Register Write, Extended Register Read, Extended Register Write, Extended Register Read Long, Extended Register Write Long, Device Descriptor Block Master Read, Device Descriptor Block Slave Read, Register 0 Write, Transfer Bus Ownership, and Parity Error |
| USB 2.0 LS/FS/HS Bus (option 6-SRUSB2): | Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special Packet, Error on USB buses up to 480 Mb/s |

Trigger system

| | |
|--|--|
| Ethernet Bus (option 6-SRENET): | Trigger on Start of Frame, MAC Addresses, MAC Q-tag, MAC Length/Type, MAC Data, IP Header, TCP Header, TCP/IPV4 Data, End of Packet, and FCS (CRC) Error on 10BASE-T and 100BASE-TX buses |
| Audio (I²S, LJ, RJ, TDM) Bus (option 6-SRAUDIO): | Trigger on Word Select, Frame Sync, or Data. Maximum data rate for I ² S/LJ/RJ is 12.5 Mb/s. Maximum data rate for TDM is 25 Mb/s |
| MIL-STD-1553 Bus (option 6-SRAERO): | Trigger on Sync, Command (Transmit/Receive Bit, Parity, Subaddress / Mode, Word Count / Mode Count, RT Address), Status (Parity, Message Error, Instrumentation, Service Request, Broadcast Command Received, Busy, Subsystem Flag, Dynamic Bus Control Acceptance, Terminal Flag), Data, Time (RT/IMG), and Error (Parity Error, Sync Error, Manchester Error, Non-contiguous Data) on MIL-STD-1553 buses |
| ARINC 429 Bus (option 6-SRAERO): | Trigger on Word Start, Label, Data, Label and Data, Word End, and Error (Any Error, Parity Error, Word Error, Gap Error) on ARINC 429 buses up to 1 Mb/s |
| Trigger holdoff range | 0 ns to 10 seconds |

Acquisition system

| | |
|------------------------------|--|
| Sample | Acquires sampled values |
| Peak Detect | Captures glitches as narrow as 160 ps at all sweep speeds |
| Averaging | From 2 to 10,240 waveforms |
| Envelope | Min-max envelope reflecting Peak Detect data over multiple acquisitions |
| High Res | <p>Applies a unique Finite Impulse Response (FIR) filter for each sample rate that maintains the maximum bandwidth possible for that sample rate while preventing aliasing and removing noise from the oscilloscope amplifiers and ADC above the usable bandwidth for the selected sample rate.</p> <p>High Res mode always provides at least 12 bits of vertical resolution and extends all the way to 16 bits of vertical resolution at ≤ 625 MS/s sample rates.</p> |
| FastAcq[®] | <p>FastAcq optimizes the instrument for analysis of dynamic signals and capture of infrequent events.</p> <p>Maximum waveform capture rate:</p> <ul style="list-style-type: none"> >500,000 wfms/s (Peak Detect or Envelope Acquisition mode) >30,000 wfms/s (All other acquisition modes) |
| Roll mode | Scrolls sequential waveform points across the display in a right-to-left rolling motion, at timebase speeds of 40 ms/div and slower, when in Auto trigger mode. |
| FastFrame[™] | <p>Acquisition memory divided into segments.</p> <p>Maximum trigger rate >5,000,000 waveforms per second</p> <p>Minimum frame size = 50 points</p> <p>Maximum Number of Frames: For frame size $\geq 1,000$ points, maximum number of frames = record length / frame size.</p> <p>For 50 point frames, maximum number of frames = 691,000</p> |

Waveform measurements

Cursor types Waveform, V Bars, H Bars, V&H Bars, and Polar (XY/XYZ plots only)

| DC voltage measurement accuracy, Average acquisition mode | Measurement Type | DC Accuracy (In Volts) |
|--|---|--|
| | Average of ≥ 16 waveforms | $\pm((\text{DC Gain Accuracy}) * \text{reading} - (\text{offset} - \text{position}) + \text{Offset Accuracy} + 0.05 * \text{V/div setting})$ |
| Delta volts between any two averages of ≥ 16 waveforms acquired with the same oscilloscope setup and ambient conditions | $\pm(\text{DC Gain Accuracy} * \text{reading} + 0.1 \text{ div})$ | |

Automatic measurements 36, of which an unlimited number can be displayed as either individual measurement badges or collectively in a measurement results table

Amplitude measurements Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Base, and Area

Timing measurements Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Time, Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, Setup Time, Hold Time, Duration N-Periods, High Time, and Low Time

Jitter measurements (standard) TIE and Phase Noise

Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition and all acquisitions

Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels can be set to global for all measurements, per source channel or signal, or unique for each measurement

Gating Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can be set to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only one Local gate is available for Screen, Cursors, Logic, and Search actions).

Measurement plots Histogram, Time Trend, Spectrum, Eye Diagram (TIE measurement only), Phase Noise (Phase Noise measurement only)

Measurement limits Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions

Jitter analysis (option 6-DJA) adds the following:

| | |
|---------------------------------|---|
| Measurements | Jitter Summary, TJ@BER, RJ- $\delta\delta$, DJ- $\delta\delta$, PJ, RJ, DJ, DDJ, DCD, SRJ, J2, J9, NPJ, F/2, F/4, F/8, Eye Height, Eye Height@BER, Eye Width, Eye Width@BER, Eye High, Eye Low, Q-Factor, Bit High, Bit Low, Bit Amplitude, DC Common Mode, AC Common Mode (Pk-Pk), Differential Crossover, T/nT Ratio, SSC Freq Dev, SSC Modulation Rate |
| Measurement plots | Eye Diagram and Jitter Bathtub Fast eye rendering: Shows the Unit Intervals (UIs) that define the boundaries of the eye along with a user specified number of surrounding UIs for added visual context Complete eye rendering: Shows all valid Unit Intervals (UIs) |
| Measurement limits | Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions |
| Eye diagram mask testing | Automated mask pass/fail testing |

Waveform measurements

Power analysis (option 6-PWR) adds the following:

| | |
|---------------------------|---|
| Measurements | Input Analysis (Frequency, V_{RMS} , I_{RMS} , voltage and current Crest Factors, True Power, Apparent Power, Reactive Power, Power Factor, Phase Angle, Harmonics, Inrush Current, Input Capacitance) |
| | Amplitude Analysis (Cycle Amplitude, Cycle Top, Cycle Base, Cycle Maximum, Cycle Minimum, Cycle Peak-to-Peak) |
| | Timing Analysis (Period, Frequency, Negative Duty Cycle, Positive Duty Cycle, Negative Pulse Width, Positive Pulse Width) |
| | Switching Analysis (Switching Loss, dv/dt, di/dt, Safe Operating Area, R_{DSon}) |
| | Magnetic Analysis (Inductance, I vs. Intg(V), Magnetic Loss, Magnetic Property) |
| | Output Analysis (Line Ripple, Switching Ripple, Efficiency, Turn-on Time, Turn-off Time) |
| | Frequency Response Analysis (Control Loop Response Bode Plot, Power Supply Rejection Ratio, Impedance) |
| Measurement Plots | Harmonics Bar Graph, Switching Loss Trajectory Plot, and Safe Operating Area |
| Measurement limits | Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions |

Digital power management (option 6-DPM) adds the following:

| | |
|---------------------|--|
| Measurements | Ripple Analysis (Ripple) |
| | Transient Analysis (Overshoot, Undershoot, Turn On Overshoot, DC Rail Voltage) |
| | Power Sequence Analysis (Turn-on, Turn-off) |
| | Jitter Analysis (TIE, PJ, RJ, DJ, Eye Height, Eye Width, Eye High, Eye Low) |

DDR3/LPDDR3 memory debug and analysis option (6-DBDDR3) adds the following:

| | |
|---------------------|---|
| Measurements | Amplitude Measurements (AOS, AUS, Vix(ac), AOS Per tCK, AUS Per tCK, AOS Per UI, AUS Per UI) |
| | Time Measurements (tRPRE, tWPRES, tPST, Hold Diff, Setup Diff, tCH(avg), tCK(avg), tCL(avg), tCH(abs), tCL(abs), tJIT(duty), tJIT(per), tJIT(cc), tERR(n), tERR(m-n), tDQSCK, tCMD-CMD, tCKSRE, tCKSRX) |

LVDS debug and analysis option (option 6-DBLVDS) adds the following:

| | |
|--------------------------------|---|
| Data Lane Measurements | Generic Test (Unit Interval, Rise Time, Fall Time, Data Width, Data Intra Skew (PN), Data Inter Skew (Lane-to-Lane), Data Peak-to-Peak) |
| | Jitter Test (AC Timing, Clock Data Setup Time, Clock Data Hold Time, Eye Diagram (TIE), TJ@BER, DJ Delta, RJ Delta, DDJ, De-Emphasis Level) |
| Clock Lane Measurements | Generic Test (Frequency, Period, Duty Cycle, Rise Time, Fall Time, Clock Intra Skew (PN), Clock Peak-to-Peak) |
| | Jitter Test (TIE, DJ, RJ) |
| | SSC On (Mod Rate, Frequency Deviation Mean) |

Waveform math

| | |
|--------------------------|---|
| Number of math waveforms | Unlimited |
| Arithmetic | Add, subtract, multiply, and divide waveforms and scalars |
| Algebraic expressions | Define extensive algebraic expressions including waveforms, scalars, user-adjustable variables, and results of parametric measurements. Perform math on math using complex equations. For example (Integral (CH1 - Mean(CH1)) X 1.414 X VAR1) |
| Math functions | Invert, Integrate, Differentiate, Square Root, Exponential, Log 10, Log e, Abs, Ceiling, Floor, Min, Max, Degrees, Radians, Sin, Cos, Tan, ASin, ACos, and ATan |
| Relational | Boolean result of comparison >, <, ≥, ≤, =, and ≠ |
| Logic | AND, OR, NAND, NOR, XOR, and EQV |
| Filtering function | User-definable filters. Users specify a file containing the coefficients of the filter |
| FFT functions | Spectral Magnitude and Phase, and Real and Imaginary Spectra |
| FFT vertical units | Magnitude: Linear and Log (dBm) Phase: Degrees, Radians, and Group Delay |
| FFT window functions | Hanning, Rectangular, Hamming, Blackman-Harris, Flattop2, Gaussian, Kaiser-Bessel, and TekExp |

Spectrum View

| Center Frequency | Limited by instrument analog bandwidth | | | | | | | | | | | | | | |
|----------------------------|--|-------------|--------|-----------------|------|------------|------|---------|------|---------|------|---------------|------|-------------|------|
| Span | 74.5 Hz – 1.25 GHz 74.5 Hz - 2 GHz (with option 6-SV-BW-1) Coarse adjustment in a 1-2-5 sequence | | | | | | | | | | | | | | |
| RF vs. Time Traces | Magnitude vs. time, Frequency vs. time, Phase vs. time | | | | | | | | | | | | | | |
| Resolution Bandwidth (RBW) | 93 μHz to 62.5 MHz 93 μHz to 100 MHz (with option 6-SV-BW-1) | | | | | | | | | | | | | | |
| Window types and factors | <table border="1"> <thead> <tr> <th>Window type</th> <th>Factor</th> </tr> </thead> <tbody> <tr> <td>Blackman-Harris</td> <td>1.90</td> </tr> <tr> <td>Flat-Top 2</td> <td>3.77</td> </tr> <tr> <td>Hamming</td> <td>1.30</td> </tr> <tr> <td>Hanning</td> <td>1.44</td> </tr> <tr> <td>Kaiser-Bessel</td> <td>2.23</td> </tr> <tr> <td>Rectangular</td> <td>0.89</td> </tr> </tbody> </table> | Window type | Factor | Blackman-Harris | 1.90 | Flat-Top 2 | 3.77 | Hamming | 1.30 | Hanning | 1.44 | Kaiser-Bessel | 2.23 | Rectangular | 0.89 |
| Window type | Factor | | | | | | | | | | | | | | |
| Blackman-Harris | 1.90 | | | | | | | | | | | | | | |
| Flat-Top 2 | 3.77 | | | | | | | | | | | | | | |
| Hamming | 1.30 | | | | | | | | | | | | | | |
| Hanning | 1.44 | | | | | | | | | | | | | | |
| Kaiser-Bessel | 2.23 | | | | | | | | | | | | | | |
| Rectangular | 0.89 | | | | | | | | | | | | | | |
| Spectrum Time | FFT Window Factor / RBW | | | | | | | | | | | | | | |
| Reference level | Reference level is automatically set by the analog channel Volts/div setting Setting range: -42 dBm to +44 dBm | | | | | | | | | | | | | | |
| Vertical Position | -100 divs to +100 divs | | | | | | | | | | | | | | |

Spectrum View

| | |
|----------------|-----------------------------------|
| Vertical units | dBm, dBμW, dBmV, dBμV, dBmA, dBμA |
|----------------|-----------------------------------|

| | |
|--------------------|-------------|
| Horizontal scaling | Linear, Log |
|--------------------|-------------|

Search

| | |
|--------------------|-----------|
| Number of searches | Unlimited |
|--------------------|-----------|

| | |
|--------------|---|
| Search types | Search through long records to find all occurrences of user specified criteria including edges, pulse widths, timeouts, runt pulses, window violations, logic patterns, setup & hold violations, rise/fall times, and bus protocol events. Search results can be viewed in the Waveform View or in the Results table. |
|--------------|---|

Save

| | |
|---------------|--|
| Waveform Type | Tektronix Waveform Data (.wfm), Comma Separated Values (.csv), MATLAB (.mat) |
|---------------|--|

| | |
|-----------------|---|
| Waveform Gating | Cursors, Screen, Resample (save every nth sample) |
|-----------------|---|

| | |
|---------------------|---|
| Screen Capture Type | Portable Network Graphic (*.png), 24-bit Bitmap (*.bmp), JPEG (*.jpg) |
|---------------------|---|

| | |
|------------|------------------------|
| Setup Type | Tektronix Setup (.set) |
|------------|------------------------|

| | |
|-------------|---|
| Report Type | Adobe Portable Documents (.pdf), Single File web Pages (.mht) |
|-------------|---|

| | |
|--------------|--------------------------------|
| Session Type | Tektronix Session Setup (.tss) |
|--------------|--------------------------------|

Display

| | |
|--------------|--|
| Display type | 15.6 in. (395 mm) liquid-crystal TFT color display |
|--------------|--|

| | |
|------------|--|
| Resolution | 1,920 horizontal × 1,080 vertical pixels (High Definition) |
|------------|--|

| | |
|---------------|---|
| Display modes | <p>Overlay: traditional oscilloscope display where traces overlay each other</p> <p>Stacked: display mode where each waveform is placed in its own slice and can take advantage of the full ADC range while still being visually separated from other waveforms. Groups of channels can also be overlaid within a slice to simplify visual comparison of signals.</p> |
|---------------|---|

| | |
|------|--|
| Zoom | Horizontal and vertical zooming is supported in all waveform and plot views. |
|------|--|

| | |
|---------------|---------------------|
| Interpolation | Sin(x)/x and Linear |
|---------------|---------------------|

| | |
|-----------------|---|
| Waveform styles | Vectors, dots, variable persistence, and infinite persistence |
|-----------------|---|

| | |
|------------|---|
| Graticules | Movable and fixed graticules, selectable between Grid, Time, Full, and None |
|------------|---|

| | |
|----------------|--|
| Color palettes | <p>Normal and inverted for screen captures</p> <p>Individual waveform colors are user-selectable</p> |
|----------------|--|

| | |
|--------|-----------------|
| Format | YT, XY, and XYZ |
|--------|-----------------|

| | |
|-------------------------------|---|
| Local Language User Interface | English, Japanese, Simplified Chinese, Traditional Chinese, French, German, Italian, Spanish, Portuguese, Russian, Korean |
|-------------------------------|---|

| | |
|---------------------|---------------------------------------|
| Local Language Help | English, Japanese, Simplified Chinese |
|---------------------|---------------------------------------|

Arbitrary/Function Generator (optional)

Function types Arbitrary, sine, square, pulse, ramp, triangle, DC level, Gaussian, Lorentz, exponential rise/fall, sin(x)/x, random noise, Haversine, Cardiac

Amplitude range Values are peak-to-peak voltages

| Waveform | 50 Ω | 1 MΩ |
|------------------|-----------------|----------------|
| Arbitrary | 10 mV to 2.5 V | 20 mV to 5 V |
| Sine | 10 mV to 2.5 V | 20 mV to 5 V |
| Square | 10 mV to 2.5 V | 20 mV to 5 V |
| Pulse | 10 mV to 2.5 V | 20 mV to 5 V |
| Ramp | 10 mV to 2.5 V | 20 mV to 5 V |
| Triangle | 10 mV to 2.5 V | 20 mV to 5 V |
| Gaussian | 10 mV to 1.25 V | 20 mV to 2.5 V |
| Lorentz | 10 mV to 1.2 V | 20 mV to 2.4 V |
| Exponential Rise | 10 mV to 1.25 V | 20 mV to 2.5 V |
| Exponential Fall | 10 mV to 1.25 V | 20 mV to 2.5 V |
| Sine(x)/x | 10 mV to 1.5 V | 20 mV to 3.0 V |
| Random Noise | 10 mV to 2.5 V | 20 mV to 5 V |
| Haversine | 10 mV to 1.25 V | 20 mV to 2.5 V |
| Cardiac | 10 mV to 2.5 V | 20 mV to 5 V |

Sine waveform

Frequency range 0.1 Hz to 50 MHz

Frequency setting resolution 0.1 Hz

Frequency accuracy 130 ppm (frequency ≤ 10 kHz), 50 ppm (frequency > 10 kHz)

This is for Sine, Ramp, Square and Pulse waveforms only.

Amplitude range 20 mV_{pp} to 5 V_{pp} into Hi-Z; 10 mV_{pp} to 2.5 V_{pp} into 50 Ω

Amplitude flatness, typical ±0.5 dB at 1 kHz

±1.5 dB at 1 kHz for < 20 mV_{pp} amplitudes

Total harmonic distortion, typical 1% for amplitude ≥ 200 mV_{pp} into 50 Ω load

2.5% for amplitude > 50 mV AND < 200 mV_{pp} into 50 Ω load

This is for Sine wave only.

Spurious free dynamic range, typical 40 dB (V_{pp} ≥ 0.1 V); 30 dB (V_{pp} ≥ 0.02 V), 50 Ω load

Square and pulse waveform

Frequency range 0.1 Hz to 25 MHz

Frequency setting resolution 0.1 Hz

Frequency accuracy 130 ppm (frequency ≤ 10 kHz), 50 ppm (frequency > 10 kHz)

Amplitude range 20 mV_{pp} to 5 V_{pp} into Hi-Z; 10 mV_{pp} to 2.5 V_{pp} into 50 Ω

Duty cycle range 10% - 90% or 10 ns minimum pulse, whichever is larger

Minimum pulse time applies to both on and off time, so maximum duty cycle will reduce at higher frequencies to maintain 10 ns off time

Duty cycle resolution 0.1%

Minimum pulse width, typical 10 ns. This is the minimum time for either on or off duration.

Rise/Fall time, typical 5 ns, 10% - 90%

Pulse width resolution 100 ps

Arbitrary/Function Generator (optional)

| | |
|---|--|
| Overshoot, typical | < 6% for signal steps greater than 100 mV _{pp} This applies to overshoot of the positive-going transition (+overshoot) and of the negative-going (-overshoot) transition |
| Asymmetry, typical | ±1% ±5 ns, at 50% duty cycle |
| Jitter, typical | < 60 ps TIE _{RMS} , ≥ 100 mV _{pp} amplitude, 40%-60% duty cycle Square and pulse waveforms, 5 GHz measurement BW. |
| Ramp and triangle waveform | |
| Frequency range | 0.1 Hz to 500 kHz |
| Frequency setting resolution | 0.1 Hz |
| Frequency accuracy | 130 ppm (frequency ≤ 10 kHz), 50 ppm (frequency > 10 kHz) |
| Amplitude range | 20 mV _{pp} to 5 V _{pp} into Hi-Z; 10 mV _{pp} to 2.5 V _{pp} into 50 Ω |
| Variable symmetry | 0% - 100% |
| Symmetry resolution | 0.1% |
| DC level range | |
| | ±2.5 V into Hi-Z ±1.25 V into 50 Ω |
| Random noise amplitude range | |
| | 20 mV _{pp} to 5 V _{pp} into Hi-Z 10 mV _{pp} to 2.5 V _{pp} into 50 Ω |
| Sin(x)/x | |
| Maximum frequency | 2 MHz |
| Gaussian pulse, Haversine, and Lorentz pulse | |
| Maximum frequency | 5 MHz |
| Lorentz pulse | |
| Frequency range | 0.1 Hz to 5 MHz |
| Amplitude range | 20 mV _{pp} to 2.4 V _{pp} into Hi-Z 10 mV _{pp} to 1.2 V _{pp} into 50 Ω |
| Cardiac | |
| Frequency range | 0.1 Hz to 500 kHz |
| Amplitude range | 20 mV _{pp} to 5 V _{pp} into Hi-Z 10 mV _{pp} to 2.5 V _{pp} into 50 Ω |
| Arbitrary | |
| Memory depth | 1 to 128 k |
| Amplitude range | 20 mV _{pp} to 5 V _{pp} into Hi-Z 10 mV _{pp} to 2.5 V _{pp} into 50 Ω |
| Repetition rate | 0.1 Hz to 25 MHz |
| Sample rate | 250 MS/s |
| Signal amplitude accuracy | ±[(1.5% of peak-to-peak amplitude setting) + (1.5% of absolute DC offset setting) + 1 mV] (frequency = 1 kHz) |
| Signal amplitude resolution | 1 mV (Hi-Z) 500 μV (50 Ω) |

Arbitrary/Function Generator (optional)

| | |
|----------------------------------|--|
| Sine and ramp frequency accuracy | 130 ppm (frequency ≤10 kHz) |
| | 50 ppm (frequency >10 kHz) |
| DC offset range | ±2.5 V into Hi-Z |
| | ±1.25 V into 50 Ω |
| DC offset resolution | 1 mV (Hi-Z) |
| | 500 μV (50 Ω) |
| DC offset accuracy | ±[(1.5% of absolute offset voltage setting) + 1 mV] Add 3 mV of uncertainty per 10 °C change from 25 °C ambient |

Digital volt meter (DVM)

| | |
|--------------------|--|
| Measurement types | DC, AC _{RMS} +DC, AC _{RMS} , Trigger frequency count |
| Voltage resolution | 4 digits |
| Voltage accuracy | |
| DC: | ±((1.5% * reading - offset - position) + (0.5% * (offset - position)) + (0.1 * Volts/div)) De-rated at 0.100%/°C of reading - offset - position above 30 °C Signal ± 5 divisions from screen center |
| AC: | ± 3% (40 Hz to 1 kHz) with no harmonic content outside 40 Hz to 1 kHz AC, typical: ± 2% (20 Hz to 10 kHz) For AC measurements, the input channel vertical settings must allow the V _{pp} input signal to cover between 4 and 10 divisions and must be fully visible on the screen |

Trigger frequency counter

| | |
|-------------------------|---|
| Resolution | 8-digits |
| Accuracy | ±(1 count + time base accuracy * input frequency) The signal must be at least 8 mV _{pp} or 2 div, whichever is greater. |
| Maximum input frequency | 10 Hz to maximum bandwidth of the analog channel The signal must be at least 8 mV _{pp} or 2 div, whichever is greater. |

Processor system

| | |
|---|--|
| Host processor | Intel i5-4400E, 2.7 GHz, 64-bit, dual core processor |
| Internal storage | ≥ 80 GB. Form factor is an 80 mm m.2 card with a SATA-3 interface |
| Operating system | |
| Solid State Drive (SSD) with Microsoft Windows 10 OS (option 6-WIN) | ≥ 480 GB SSD. Form factor is a 2.5-inch SSD with a SATA-3 interface. This drive is customer installable and includes the Microsoft Windows 10 Enterprise IoT 2016 LTSC (64-bit) operating system |

Input-Output ports

| DisplayPort connector | A 20-pin DisplayPort connector; connect to show the oscilloscope display on an external monitor or projector | | | | | | |
|---|--|----------------|--------|-----------|---|-----------|--|
| DVI connector | A 29-pin DVI-I connector; connect to show the oscilloscope display on an external monitor or projector | | | | | | |
| VGA | DB-15 female connector; connect to show the oscilloscope display on an external monitor or projector | | | | | | |
| Probe compensator signal, typical | | | | | | | |
| Connection: | Connectors are located on the lower front right of the instrument | | | | | | |
| Amplitude: | 0 to 2.5 V | | | | | | |
| Frequency: | 1 kHz | | | | | | |
| Source impedance: | 1 k Ω | | | | | | |
| External reference input | The time-base system can phase lock to an external 10 MHz reference signal . There are two ranges for the reference clock. The instrument can accept a high-accuracy reference clock of 10 MHz \pm 2 ppm or a lower-accuracy reference clock of 10 MHz \pm 1 kppm. | | | | | | |
| USB interface (Host, Device ports) | Front panel USB Host ports: Two USB 2.0 Hi-Speed ports, one USB 3.0 SuperSpeed port Rear panel USB Host ports: Two USB 2.0 Hi-Speed ports, two USB 3.0 SuperSpeed ports Rear panel USB Device port: One USB 3.0 SuperSpeed Device port providing USBTMC support | | | | | | |
| Ethernet interface | 10/100/1000 Mb/s | | | | | | |
| Auxiliary output | Rear-panel BNC connector. Output can be configured to provide a positive or negative pulse out when the oscilloscope triggers, the internal oscilloscope reference clock out, or an AFG sync pulse | | | | | | |
| | <table border="1"> <thead> <tr> <th>Characteristic</th> <th>Limits</th> </tr> </thead> <tbody> <tr> <td>Vout (HI)</td> <td>≥ 2.5 V open circuit; ≥ 1.0 V into a 50 Ω load to ground</td> </tr> <tr> <td>Vout (LO)</td> <td>≤ 0.7 V into a load of ≤ 4 mA; ≤ 0.25 V into a 50 Ω load to ground</td> </tr> </tbody> </table> | Characteristic | Limits | Vout (HI) | ≥ 2.5 V open circuit; ≥ 1.0 V into a 50 Ω load to ground | Vout (LO) | ≤ 0.7 V into a load of ≤ 4 mA; ≤ 0.25 V into a 50 Ω load to ground |
| Characteristic | Limits | | | | | | |
| Vout (HI) | ≥ 2.5 V open circuit; ≥ 1.0 V into a 50 Ω load to ground | | | | | | |
| Vout (LO) | ≤ 0.7 V into a load of ≤ 4 mA; ≤ 0.25 V into a 50 Ω load to ground | | | | | | |
| Kensington-style lock | Rear-panel security slot connects to standard Kensington-style lock | | | | | | |
| LXI | Class: LXI Core 2011 Version: 1.4 | | | | | | |

Power source

| | |
|--------------------------|--|
| Power | |
| Power consumption | 400 Watts maximum |
| Source voltage | 100 - 240 V \pm 10% at 50 Hz to 60 Hz 115 V \pm 10% at 400 Hz |

Physical characteristics

| | |
|--------------------------------|---|
| Dimensions | <p>Height: 12.2 in (309 mm), feet folded in, handle to back</p> <p>Height: 14.6 in (371 mm) feet folded in, handle up</p> <p>Width: 17.9 in (454 mm) from handle hub to handle hub</p> <p>Depth: 8.0 in (205 mm) from back of feet to front of knobs, handle up</p> <p>Depth: 11.7 in (297.2 mm) feet folded in, handle to the back</p> |
| Weight | < 28.4 lbs (12.88 kg) |
| Cooling | The clearance requirement for adequate cooling is 2.0 in (50.8 mm) on the right side of the instrument (when viewed from the front) and on the rear of the instrument |
| Rackmount configuration | 7U (with optional RM6 Rackmount Kit) |

Environmental specifications

| | |
|----------------------|---|
| Temperature | |
| Operating | +0 °C to +50 °C (32 °F to 122 °F) |
| Non-operating | -20 °C to +60 °C (-4 °F to 140 °F) |
| Humidity | |
| Operating | 5% to 90% relative humidity (% RH) at up to +40 °C 5% to RH above +40 °C up to +50 °C, noncondensing |
| Non-operating | 5% to 90% relative humidity (% RH) at up to +60 °C, noncondensing |
| Altitude | |
| Operating | Up to 3,000 meters (9,843 feet) |
| Non-operating | Up to 12,000 meters (39,370 feet) |

EMC, Environmental, and Safety

| | |
|-------------------|--|
| Regulatory | <p>CE marked for the European Union and UL approved for the USA and Canada</p> <p>RoHS compliant</p> |
|-------------------|--|

Software

| | |
|-----------------------------|--|
| Software | |
| IVI driver | Provides a standard instrument programming interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET, and MATLAB. Compatible with Python, C/C++/C# and many other languages through VISA. |
| e*Scope® | Enables control of the oscilloscope over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Transfer and save settings, waveforms, measurements, and screen images or make live control changes to settings on the oscilloscope directly from the web browser. |
| LXI Web interface | Connect to the oscilloscope through a standard Web browser by simply entering the oscilloscope's IP address or network name in the address bar of the browser. The Web interface enables viewing of instrument status and configuration, status and modification of network settings, and instrument control through the e*Scope web-based remote control. |
| Programming Examples | Programming with the 4/5/6 Series platforms has never been easier. With a programmers manual and a GitHub site you have many commands and examples to help you get started remotely automating your instrument. See https://github.com/tektronix/Programmatic-Control-Examples . |

Ordering information

Use the following steps to select the appropriate instrument and options for your measurement needs.

Step 1

Start by selecting the MSO64 model.

| Model | Number of FlexChannels |
|-------|------------------------|
| MSO64 | 4 |

| Each model includes |
|--|
| Four TPP1000 1 GHz probes. |
| Installation and safety manual (translated in English, Japanese, Simplified Chinese) |
| Embedded Help |
| Front cover with integrated accessory pouch |
| Mouse |
| Power cord |
| Calibration certificate documenting traceability to National Metrology Institute(s) and ISO9001/ISO17025 quality system registration |
| Three-year warranty covering all parts and labor on the instrument. One-year warranty covering all parts and labor on included probes |

Step 2

Configure your oscilloscope by selecting the analog channel bandwidth you need

Choose the bandwidth you need today by choosing one of these bandwidth options. You can upgrade it later by purchasing an upgrade option.

| Bandwidth Option | Bandwidth |
|------------------|-----------|
| 6-BW-1000 | 1 GHz |
| 6-BW-2500 | 2.5 GHz |
| 6-BW-4000 | 4 GHz |
| 6-BW-6000 | 6 GHz |
| 6-BW-8000 | 8 GHz |

Note: For instruments of 4, 6, or 8 GHz bandwidth, consider a BNC-to-SMA adapter to optimize a high bandwidth connection to the oscilloscope. Tektronix part number 103-0503-xx.

Step 3

Add instrument functionality

Instrument functionality can be ordered with the instrument or later as an upgrade kit.

| Instrument Option | Built-in Functionality |
|----------------------|--|
| 6-RL-1 | Extend record length from 62.5 Mpoints/channel to 125 Mpoints/channel |
| 6-RL-2 | Extend record length from 62.5 Mpoints/channel to 250 Mpoints/channel |
| 6-WIN ⁶ | Add removable SSD with Microsoft Windows 10 operating system license |
| 6-AFG | Add Arbitrary / Function Generator |
| 6-SEC ^{7 8} | Add enhanced security for instrument declassification and password-protected enabling and disabling of all USB ports and firmware upgrade. |

Step 4

Add optional serial bus triggering, decode, and search capabilities

Choose the serial support you need today by choosing from these serial analysis options. You can upgrade later by purchasing an upgrade kit.

| Instrument Option | Serial Buses Supported |
|-------------------|---|
| 6-SRAERO | Aerospace (MIL-STD-1553, ARINC 429) |
| 6-SRAUDIO | Audio (I ² S, LJ, RJ, TDM) |
| 6-SRAUTO | Automotive (CAN, CAN FD, LIN, FlexRay, and CAN symbolic decoding) |
| 6-SRAUTOEN1 | 100BASE-T1 Automotive Ethernet serial analysis |
| 6-SRAUTOSEN | Automotive sensor (SENT) |
| 6-SRCOMP | Computer (RS-232/422/485/UART) |
| 6-SREMBD | Embedded (I ² C, SPI) |
| 6-SRENET | Ethernet (10BASE-T, 100BASE-TX) |
| 6-SR8B10B | 8B/10B (decode and search only) |
| 6-SRI3C | MIPI I3C (I3C decode and search only) |
| 6-SRNRZ | NRZ (decode and search only) |
| 6-SRPM | Power Management (SPMI) |
| 6-SRPSI5 | PSI5 (decode and search only) |
| 6-SRSPACEWIRE | Spacewire (decode and search only) |
| 6-SRUSB2 | USB (USB2.0 LS, FS, HS) |

Differential serial bus? Be sure to check *Add analog probes and adapters* for differential probes.

⁶ This option is not compatible with option 6-SEC.

⁷ This option is not compatible with option 6-WIN.

⁸ This option must be purchased at the same time as the instrument. Not available as an upgrade.

Step 5

Add optional serial bus compliance testing

Choose the serial compliance testing packages you need today by choosing from these options. You can upgrade later by purchasing an upgrade kit. All options in the table below require option 6-WIN (SSD with Microsoft Windows 10 operating system).

| Instrument Option | Serial Buses Supported |
|-------------------|---|
| 6-CMAUTOEN | Automotive Ethernet (100Base-T1, 1000Base-T1) automated compliance test solution. ≥ 2 GHz bandwidth required for 1000BASE-T1 |
| 6-AUTOEN-BND | Automotive Ethernet Compliance, Signal Separation, PAM3 Analysis, 100Base-T1 Decode software (requires options 6-DJA and 6-WIN) |
| 6-AUTOEN-SS | Automotive Ethernet Signal Separation |
| 6-CMINDUEN10 | Industrial Ethernet (10Base-T1L Long Reach) automated compliance test solution |
| 6-CMDPHY | MIPI D-DPHY 1.2 automated compliance test solution. |
| 6-CMENET | Ethernet automated compliance test solution (10BASE-T/100BASE-T/1000BASE-T). ≥ 1 GHz bandwidth required for 1000BASE-T |
| 6-CMNBASET | 2.5 and 5 GBASE-T Ethernet automated compliance test solution. 2.5 GHz is recommended |
| 6-CMXGBT | 10 GBASE-T Ethernet automated compliance test solution. ≥ 4 GHz is recommended |
| 6-CMUSB2 | USB2.0 automated compliance test solution. Requires TDSUSBF USB test fixture ≥ 2 GHz bandwidth required for high-speed USB |

Step 6

Add optional memory analysis

| Instrument Option | Advanced Analysis |
|-------------------|--|
| 6-DBDDR3 | DDR3 and LPDDR3 Debug and Analysis |
| 6-CMDDR3 | DDR3 and LPDDR3 automated compliance test solution using TekExpress Automation Platform. Requires options 6-DBDDR3, 6-DJA and 6-WIN (SSD with Microsoft Windows 10 operating system). ≥ 4 GHz required, 8 GHz recommended for testing of all DDR3 speeds. |

Step 7

Add optional analysis capabilities

| Instrument Option | Advanced Analysis |
|-------------------|--|
| 6-DBLVDS | TekExpress automated LVDS test solution (requires options 6-DJA and 6-WIN) |
| 6-DJA | Advanced Jitter and Eye Analysis |
| 6-DPM | Digital Power Management |
| 6-MTM | Mask and Limit testing |
| 6-PAM3 | PAM3 Analysis (requires options 6-DJA and 6-WIN) |
| 6-PWR | Power Measurement and Analysis |
| 6-SV-BW-1 | Increase Spectrum View Capture Bandwidth to 2 GHz |
| 6-SV-RFVT | Spectrum View RF versus Time Analysis and remote IQ data transferring |
| 6-VID | NTSC, PAL, and SECAM video triggering |

Step 8

Add digital probes

Each FlexChannel input can be configured as eight digital channels simply by connecting a TLP058 logic probe.

| For this instrument | Order | To add |
|---------------------|----------------------|--------------------------|
| MSO64 | 1 to 4 TLP058 Probes | 8 to 32 digital channels |

Step 9

Add analog probes and adapters

Add additional recommended probes and adapters

| Recommended Probe / Adapter | Description |
|-----------------------------|--|
| TAP1500 | 1.5 GHz TekVPI® active single-ended voltage probe, ±8 V input voltage |
| TAP2500 | 2.5 GHz TekVPI® active single-ended voltage probe, ±4 V input voltage |
| TAP3500 | 3.5 GHz TekVPI® active single-ended voltage probe, ±4 V input voltage |
| TAP4000 | 4 GHz TekVPI® active single-ended voltage probe, ±4 V input voltage |
| TCP0020 | 20 A AC/DC TekVPI® current probe, 50 MHz BW |
| TCP0030A | 30 A AC/DC TekVPI current probe, 120 MHz BW |
| TCP0150 | 150 A AC/DC TekVPI® current probe, 20 MHz BW |
| TCPA300 | 100 MHz Current Probe, Amplifier (Requires Probe); Recommend using TPA-BNC adapter to provide autoscaling. |
| TCP312A | DC-100 MHz, AC/DC Current Probe; 30 Amp DC |
| TRCP0300 | 30 MHz AC current probe, 250 mA to 300 A |
| TRCP0600 | 30 MHz AC current probe, 500 mA to 600 A |
| TRCP3000 | 16 MHz AC current probe, 500 mA to 3000 A |
| TDP0500 | 500 MHz TekVPI® differential voltage probe, ±42 V differential input voltage |
| TDP1000 | 1 GHz TekVPI® differential voltage probe, ±42 V differential input voltage |
| TDP1500 | 1.5 GHz TekVPI® differential voltage probe, ±8.5 V differential input voltage |
| TDP3500 | 3.5 GHz TekVPI® differential voltage probe, ±2 V differential input voltage |
| TDP4000 | 4 GHz TekVPI® differential voltage probe, ±2 V differential input voltage |
| TDP7704 | 4 GHz TriMode™ voltage probe |
| TDP7706 | 6 GHz TriMode™ voltage probe |
| TDP7708 | 8 GHz TriMode™ voltage probe |
| THDP0100 | ±6 kV, 100 MHz TekVPI® high-voltage differential probe |
| THDP0200 | ±1.5 kV, 200 MHz TekVPI® high-voltage differential probe |
| TMDP0200 | ±750 V, 200 MHz TekVPI® high-voltage differential probe |
| TPR1000 | 1 GHz, Single-Ended TekVPI® Power-Rail Probe; includes one TPR4KIT accessory kit |
| TPR4000 | 4 GHz, Single-Ended TekVPI® Power-Rail Probe; includes one TPR4KIT accessory kit |
| TIVH02 | Isolated Probe; 200 MHz, ±2500 V, TekVPI, 3 Meter Cable |
| TIVH02L | Isolated Probe; 200 MHz, ±2500 V, TekVPI, 10 Meter Cable |
| TIVH05 | Isolated Probe; 500 MHz, ±2500 V, TekVPI, 3 Meter Cable |
| TIVH05L | Isolated Probe; 500 MHz, ±2500 V, TekVPI, 10 Meter Cable |
| TIVH08 | Isolated Probe; 800 MHz, ±2500 V, TekVPI, 3 Meter Cable |
| TIVH08L | Isolated Probe; 800 MHz, ±2500 V, TekVPI, 10 Meter Cable |
| TIVM1 | Isolated Probe; 1 GHz, ±50 V, TekVPI, 3 Meter Cable |
| TIVM1L | Isolated Probe; 1 GHz, ±50 V, TekVPI, 10 Meter Cable |
| TPP0502 | 500 MHz, 2X TekVPI® passive voltage probe, 12.7 pF input capacitance |
| TPP0850 | 2.5 kV, 800 MHz, 50X TekVPI® passive high-voltage probe |
| P6015A | 20 kV, 75 MHz high-voltage passive probe |
| TPA-BNC ⁹ | TekVPI® to TekProbe™ BNC adapter |
| 103-0503-xx | BNC-to-SMA adapter; rated to 12 GHz |

⁹ Recommended for connecting your existing TekProbe probes to the 6 Series MSO.

| Recommended Probe / Adapter | Description |
|-----------------------------|--|
| TEK-DPG | TekVPI deskew pulse generator signal source |
| 067-1686-xx | Power measurement deskew and calibration fixture |

Looking for other probes? Check out the probe selector tool at www.tek.com/probes.

Step 10

Add accessories

Add traveling or mounting accessories

| Optional Accessory | Description |
|--------------------------|---|
| HC5 | Hard carrying case |
| RM5 | Rackmount kit |
| GPIB to Ethernet adapter | Order model 4865B (GPIB to Ethernet to Instrument Interface) directly from ICS Electronics www.icselect.com/gpib_instrument_intf.html |

Step 11

Select power cord option

| Power Cord Option | Description |
|-------------------|--|
| A0 | North America power plug (115 V, 60 Hz) |
| A1 | Universal Euro power plug (220 V, 50 Hz) |
| A2 | United Kingdom power plug (240 V, 50 Hz) |
| A3 | Australia power plug (240 V, 50 Hz) |
| A5 | Switzerland power plug (220 V, 50 Hz) |
| A6 | Japan power plug (100 V, 50/60 Hz) |
| A10 | China power plug (50 Hz) |
| A11 | India power plug (50 Hz) |
| A12 | Brazil power plug (60 Hz) |
| A99 | No power cord |

Step 12**Add extended service and calibration options**

| Service Option | Description |
|----------------|---|
| T3 | Three Year Total Protection Plan, includes repair or replacement coverage from wear and tear, accidental damage, ESD or EOS. |
| T5 | Five Year Total Protection Plan, includes repair or replacement coverage from wear and tear, accidental damage, ESD or EOS. |
| G3 | Three Year Gold Care Plan. Includes expedited repair of all product failures including ESD and EOS, access to a loaner product during repair or advanced exchange to reduce downtime, priority access to Customer Support among others. |
| G5 | Five Year Gold Care Plan. Includes expedited repair of all product failures including ESD and EOS, access to a loaner product during repair or advanced exchange to reduce downtime, priority access to Customer Support among others. |
| R5 | Standard Warranty Extended to 5 Years. Covers parts, labor and 2-day shipping within country. Guarantees faster repair time than without coverage. All repairs include calibration and updates. Hassle free - a single call starts the process. |
| C3 | Calibration service 3 Years. Includes traceable calibration or functional verification where applicable, for recommended calibrations. Coverage includes the initial calibration plus 2 years calibration coverage. |
| C5 | Calibration service 5 Years. Includes traceable calibration or functional verification where applicable, for recommended calibrations. Coverage includes the initial calibration plus 4 years calibration coverage. |
| D1 | Calibration Data Report |
| D3 | Calibration Data Report 3 Years (with Option C3) |
| D5 | Calibration Data Report 5 Years (with Option C5) |

Feature upgrades after purchase

Add feature upgrades in the future The 6 Series products offer many ways to easily add functionality after the initial purchase. Node-locked licenses permanently enable optional features on a single product. Floating licenses allow license-enabled options to be easily moved between compatible instruments.

| Upgrade feature | Node-locked license upgrade | Floating license upgrade | Description |
|--|-----------------------------|---|---|
| Add instrument functions | SUP6-AFG | SUP6-AFG-FL | Add arbitrary function generator |
| | SUP6-RL-2 | SUP6-RL-2-FL | Extend record length to 250 Mpts / channel |
| Add protocol analysis | SUP6-SRAERO | SUP6-SRAERO-FL | Aerospace serial triggering and analysis (MIL-STD-1553, ARINC 429) |
| | SUP6-SRAUDIO | SUP6-SRAUDIO-FL | Audio serial triggering and analysis (I ² S, LJ, RJ, TDM) |
| | SUP6-SRAUTO | SUP6-SRAUTO-FL | Automotive serial triggering and analysis (CAN, CAN FD, LIN, FlexRay, and CAN symbolic decoding) |
| | SUP6-SRAUTOEN1 | SUP6-SRAUTOEN1-FL | 100Base-T1 Automotive Ethernet serial analysis |
| | SUP6-SRAUTOSEN | SUP6-SRAUTOSEN-FL | Automotive sensor serial triggering and analysis (SENT) |
| | SUP6-SRCOMP | SUP6-SRCOMP-FL | Computer serial triggering and analysis (RS-232/422/485/UART) |
| | SUP6-SREMBD | SUP6-SREMBD-FL | Embedded serial triggering and analysis (I ² C, SPI) |
| | SUP6-SRENET | SUP6-SRENET-FL | Ethernet serial triggering and analysis (10Base-T, 100Base-TX) |
| | SUP6-SRI3C | SUP6-SRI3C-FL | MIPI I3C serial decoding and analysis |
| | SUP6-SR8B10B | SUP6-SR8B10B-FL | 8b/10b serial decoding and analysis |
| | SUP6-SRNRZ | SUP6-SRNRZ-FL | NRZ serial decoding and analysis |
| | SUP6-SRPM | SUP6-SRPM-FL | Power Management serial triggering and analysis (SPMI) |
| | SUP6-SRPSI5 | SUP6-SRPSI5-FL | PSI5 serial decoding and analysis |
| | SUP6-SRSPACEWIRE | SUP6-SRSPACEWIRE-FL | Spacewire serial analysis |
| SUP6-SRUSB2 | SUP6-SRUSB2-FL | USB 2.0 serial bus triggering and analysis (LS, FS, HS) | |
| Add serial compliance | SUP6-CMAUTOEN | SUP6-CMAUTOEN-FL | Automotive Ethernet automated compliance test solution (100BASE-T1 and 1000BASE-T1) |
| All serial compliance products require option 6-WIN (SSD with Microsoft Windows 10 operating system) | SUP6-AUTOEN-BND | | Automotive Ethernet compliance, signal separation, PAM3 analysis, 100Base-T1 serial analysis (requires options 6-DJA and 6-WIN) |
| | SUP6-AUTOEN-SS | SUP6-AUTOEN-SS-FL | Automotive Ethernet signal separation |
| | SUP6-CMINDUEN10 | SUP6-CMINDUEN10-FL | Industrial Ethernet (10Base-T1L Long Reach) automated compliance test solution |
| | SUP6-CMDPHY | SUP6-CMDPHY-FL | MIPI D-PHY 1.2 automated compliance test solution |
| | SUP6-CMENET | SUP6-CMENET-FL | Ethernet automated compliance test solution (10BASE-T, 100BASE-T, and 1000BASE-T) Requires SSD with Microsoft Windows 10 operating system |
| | SUP6-CMNBASET | SUP6-CMNBASET-FL | 2.5 and 5 GBASE-T Ethernet automated compliance test (2.5 GHz is recommended) |
| | SUP6-CMUSB2 | SUP6-CMUSB2-FL | USB 2.0 automated compliance test solution |

| Upgrade feature | Node-locked license upgrade | Floating license upgrade | Description |
|-----------------------|-----------------------------|--------------------------|--|
| Add advanced analysis | SUP6-DBLVDS | SUP6-DBLVDS-FL | LVDS debug and analysis (requires options 6-DJA and 6-WIN) |
| | SUP6-DJA | SUP6-DJA-FL | Advanced jitter and eye analysis |
| | SUP6-DPM | SUP6-DPM-FL | Digital power management |
| | SUP6-MTM | SUP6-MTM-FL | Mask and Limit testing |
| | SUP6-PAM3 | SUP6-PAM3-FL | PAM3 analysis (requires options 6-DJA and 6-WIN) |
| | SUP6-PWR | SUP6-PWR-FL | Advanced power measurements and analysis |
| | SUP6-SV-BW-1 | SUP6-SV-BW-1-FL | Increase Spectrum View capture bandwidth to 2 GHz |
| | SUP6-SV-RFVT | SUP6-SV-RFVT-FL | Spectrum View RF versus time analysis |
| | SUP6-VID | SUP6-VID-FL | NTSC, PAL, and SECAM video triggering |
| Add memory analysis | SUP6-DBDDR3 | SUP6-DBDDR3-FL | DDR3 and LPDDR3 debug and analysis |
| | SUP6-CMDDR3 | SUP6-CMDDR3-FL | DDR3 and LPDDR3 automated compliance test solution using TekExpress Automation Platform. Requires options 6-DBDDR3, 6-DJA and SSD with Microsoft Windows 10 operating system. ≥4 GHz required, 8 GHz recommended for testing of all DDR3 speeds. |
| Add digital voltmeter | SUP6-DVM | N/A | Add digital voltmeter / trigger frequency counter (Free with product registration at www.tek.com/register6mso) |

| Upgrade feature | Upgrade | Description |
|------------------------------|----------|--|
| Add Windows operating system | SUP6-WIN | Add removable SSD with Windows 10 operating system |

Bandwidth upgrades after purchase

Add bandwidth upgrades in the future

The analog bandwidth of 6 Series products can be upgraded after initial purchase. Bandwidth upgrades are purchased based on the current bandwidth and the desired bandwidth. All bandwidth upgrades can be performed in the field by installing a software license and a new front panel label.

| Model to be upgraded | Bandwidth before upgrade | Bandwidth after upgrade | Order this bandwidth upgrade |
|----------------------|--------------------------|-------------------------|------------------------------|
| MSO64 | 1 GHz | 2.5 GHz | SUP6-BW10T254 |
| | 1 GHz | 4 GHz | SUP6-BW10T404 |
| | 1 GHz | 6 GHz | SUP6-BW10T604 |
| | 1 GHz | 8 GHz | SUP6-BW10T804 |
| | 2.5 GHz | 4 GHz | SUP6-BW25T404 |
| | 2.5 GHz | 6 GHz | SUP6-BW25T604 |
| | 2.5 GHz | 8 GHz | SUP6-BW25T804 |
| | 4 GHz | 6 GHz | SUP6-BW40T604 |
| | 4 GHz | 8 GHz | SUP6-BW40T804 |
| | 6 GHz | 8 GHz | SUP6-BW60T804 |



Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.



Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.



Product Area Assessed: The planning, design/development and manufacture of electronic Test and Measurement instruments.

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